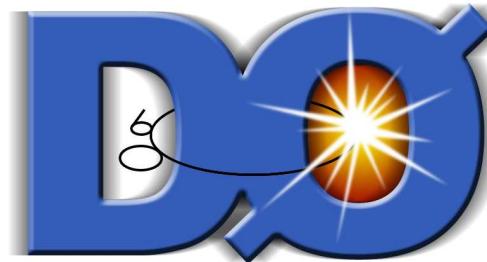

B_s Lifetime Difference and Mixing @ the Tevatron

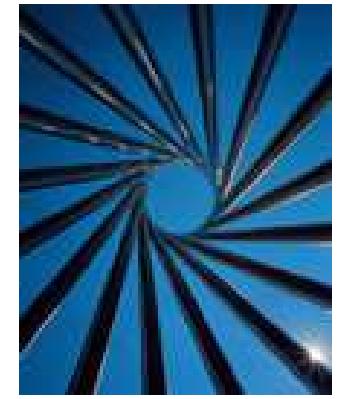
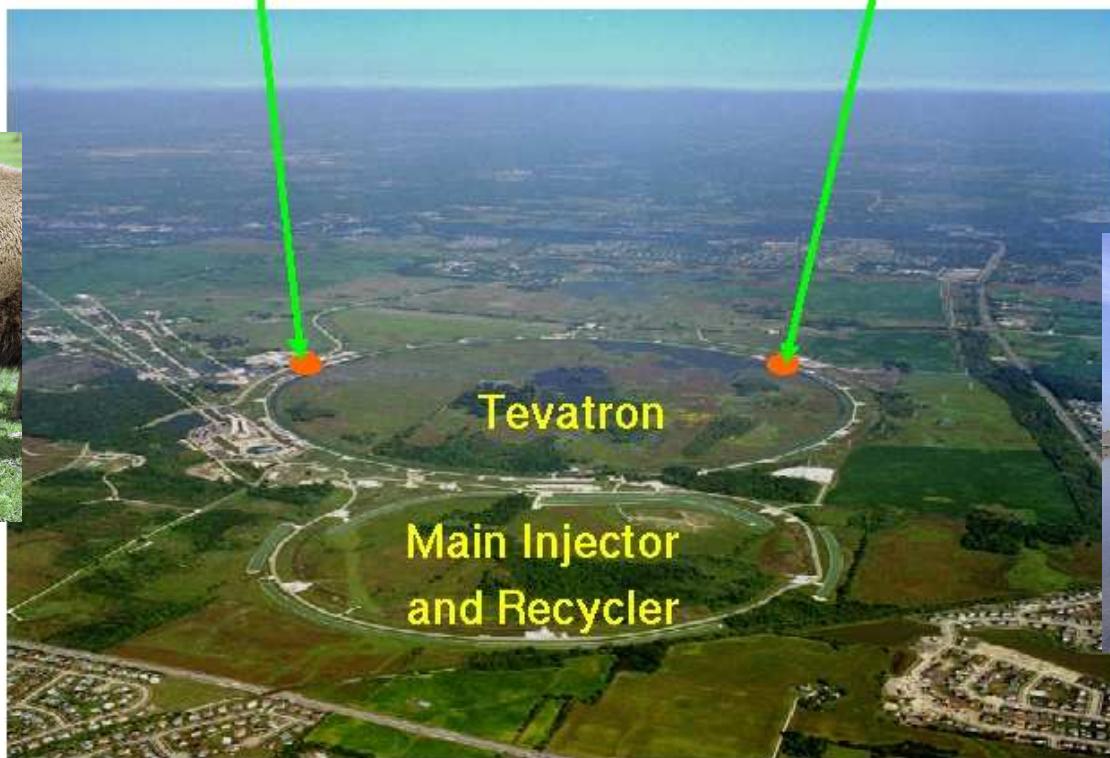
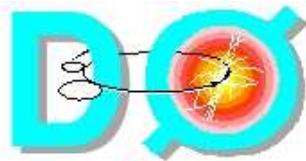
Stephanie Menzemer

Physikalisches Institut,
Ruprecht-Karls-Universität Heidelberg

Munich, 17th of October 2006



Tevatron



$p\bar{p}$ collisions at $\sqrt{s} = 1.96$ TeV observed by two experiments
CDF & D0

B Physics @ Hadron Colliders

- + Large cross section

$$\sigma(p\bar{p} \rightarrow bX) \approx 100 \mu b$$

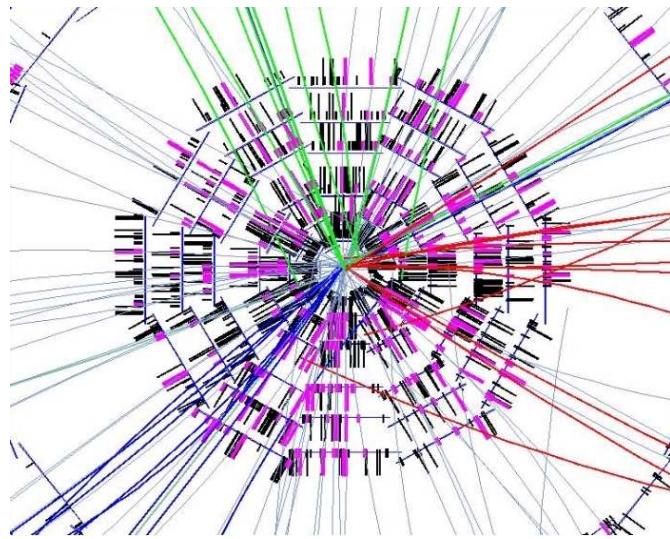
↔ *B* factories: ≈ 1 nb

- + High center-of-mass energy

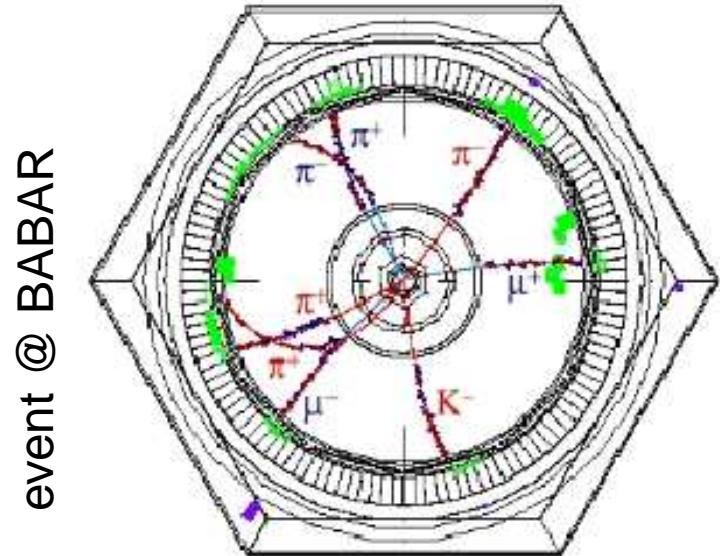
- + Heavy & excited *B*'s,

e.g. B_s , B_c , Λ_b , Ξ_b , B^{**} , B_s^{**} , ...

- $\sigma(p\bar{p} \rightarrow X)$ O(10^3) higher
→ require excellent trigger
- High track density
→ require dedicated algorithms



event @ CDF



event @ BABAR

Tevatron unique place to study large amounts of B_s Mesons.

Selected B_s Topics

Many exciting B analysis going on at the Tevatron
today ...

- $\Delta\Gamma_s$ and CP violation
- $B_s - \bar{B}_s$ oscillations

for more Tevatron B physics results see:

- **B Lifetimes, CP Violation and Rare Decays**
(Monday, 16th of October; Cano Ay)
- **Spectroscopy and Decays of B Hadrons**
(Thursday, 19th of October; Manfred Paulini)

$\Delta\Gamma_s$ and CP violation

Different Approaches to $\Delta\Gamma_s$

$\Delta\Gamma_s$: decay-width difference between heavy (CP odd) and light (CP even) mass eigenstate:

$$\Delta\Gamma_s = \Delta\Gamma_s^{SM,CP} \times \cos(\phi_s^{SM} + \phi_s^{NP}); \quad \phi_s^{SM} \approx 0.0$$
$$\left(\frac{\Delta\Gamma_s}{\Delta m_s} \approx \frac{3}{2}\pi \frac{m_b^2}{m_t^2} = 3.7_{-1.5}^{+0.8} 10^{-3} \right)$$

Many orthogonal measurements ongoing:

- Directly measure lifetimes in $B_s \rightarrow J/\psi\phi$
separate CP states by angular distribution, measure lifetimes
- Measure lifetime in $B_s \rightarrow K^+K^-$ (CP even);
compare to PDG lifetime for flavor specific states (see Cano Ay's talk)
- Measure $\text{BR}(B_s \rightarrow D_s^{(*)} D_s^{(*)}) \propto \Delta\Gamma_s/\Gamma_s$, (CP even);
account for most of lifetime difference (see Manfred Paulini's talk)
- Measure time-integrated untagged decay rate asymmetry
 $A_{SL}^s = \frac{\Delta\Gamma_s}{\Delta m_s} \tan(\phi_s)$ (see Cano Ay's talk)

D0: $\Delta\Gamma_s$ via $B_s \rightarrow J/\psi\phi$

$B_s \rightarrow J/\psi\phi$: Pseudoscalar \rightarrow Vector Vector decay

Simultaneous fit for angular distributions and short and long B_s lifetime

A_0 : S + D wave \rightarrow P even

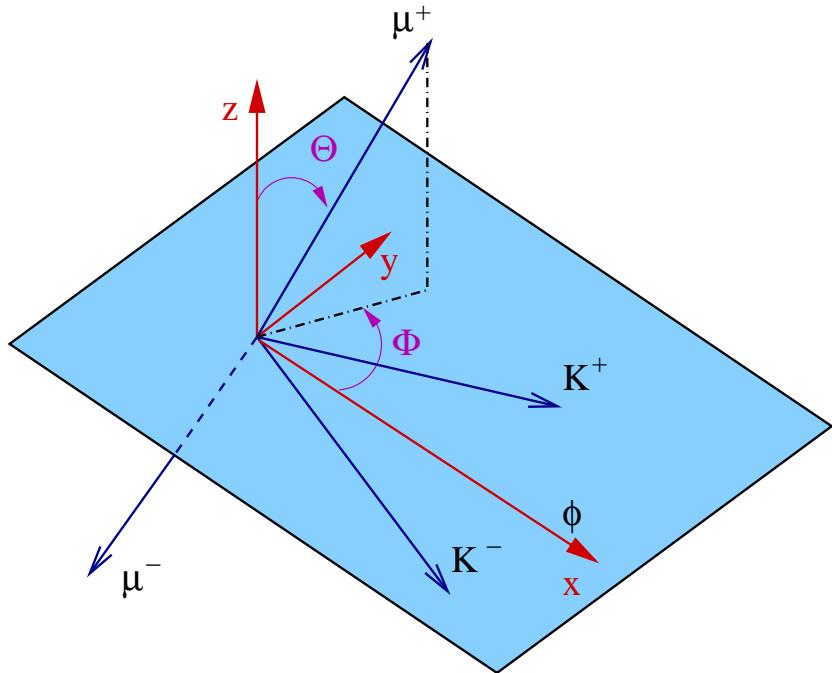
A_{\parallel} : S + D wave \rightarrow P even

A_{\perp} : P wave \rightarrow P odd

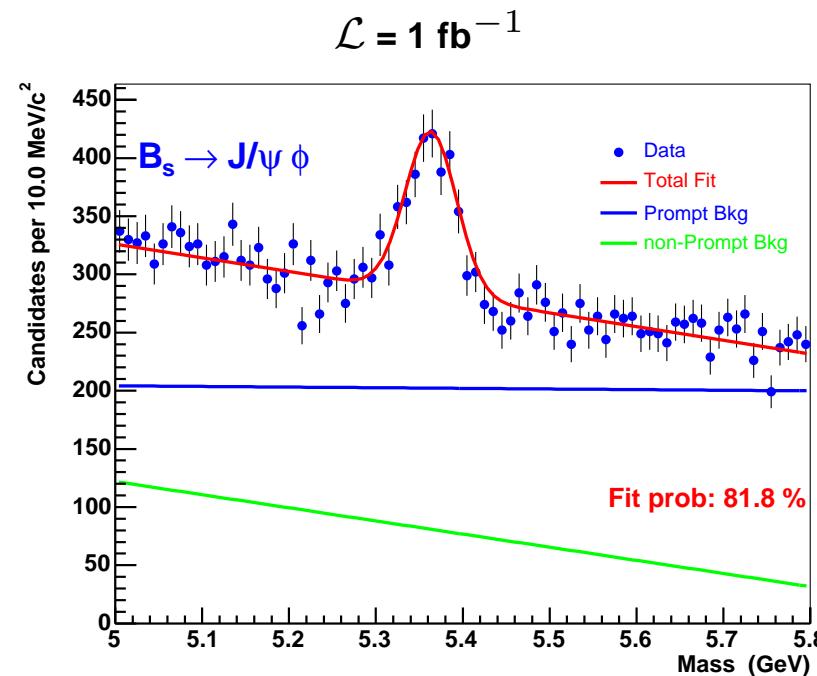
without CP violation:

$B_{s,Short,Light} \rightarrow CP$ even

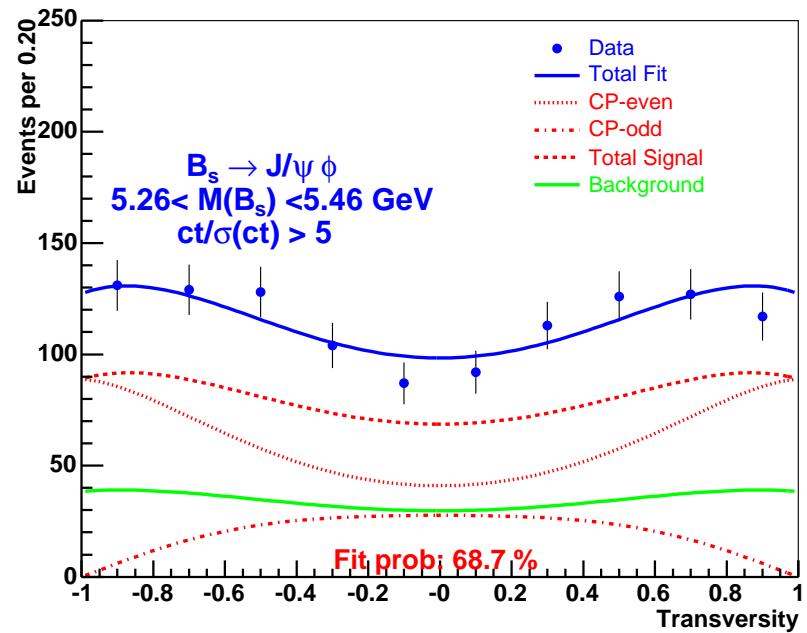
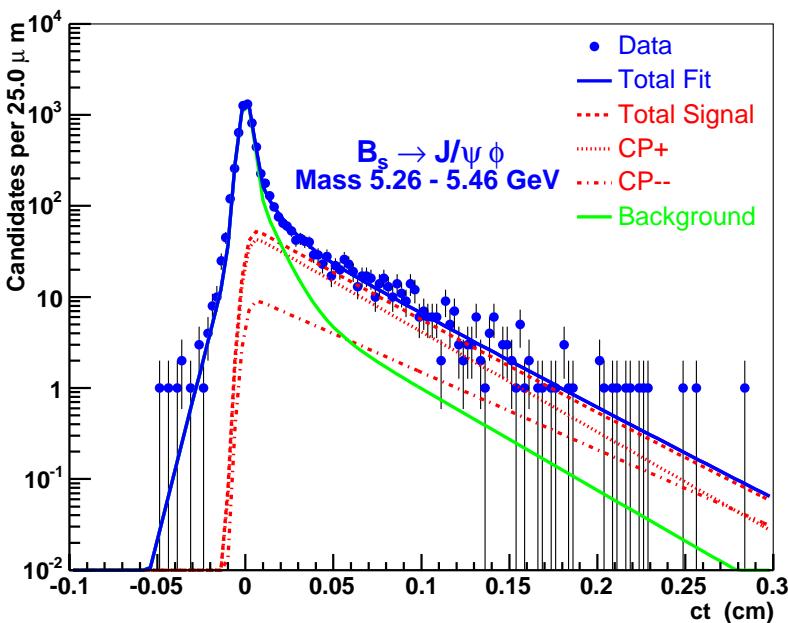
$B_{s,Long,Heavy} \rightarrow CP$ odd



Use transversity basis to resolve
angular dependencies



D0: Results on $\Delta\Gamma_s$

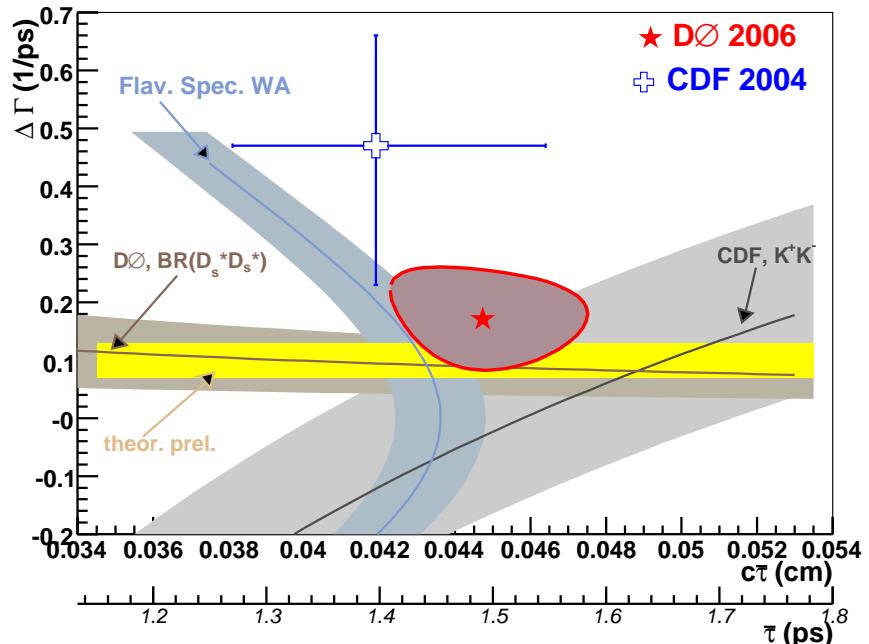


Assuming no CP violation:

$$\Delta\Gamma_s = 0.12 \pm 0.08 \pm 0.03 \text{ ps}^{-1}$$

Non 0 $\Delta\Gamma_s$!

Putting all measurements together ...



D0: $\Delta\Gamma_s$ CP Violation Results

- Allowing for CP violation

$$\Delta\Gamma_s = \Delta\Gamma_s^{SM,CP} \times \cos(\phi_s)$$

$$\Delta\Gamma_s = 0.17 \pm 0.09 \pm 0.03 \text{ ps}^{-1}$$

$$\phi_s = -0.79 \pm 0.56 \pm 0.01$$

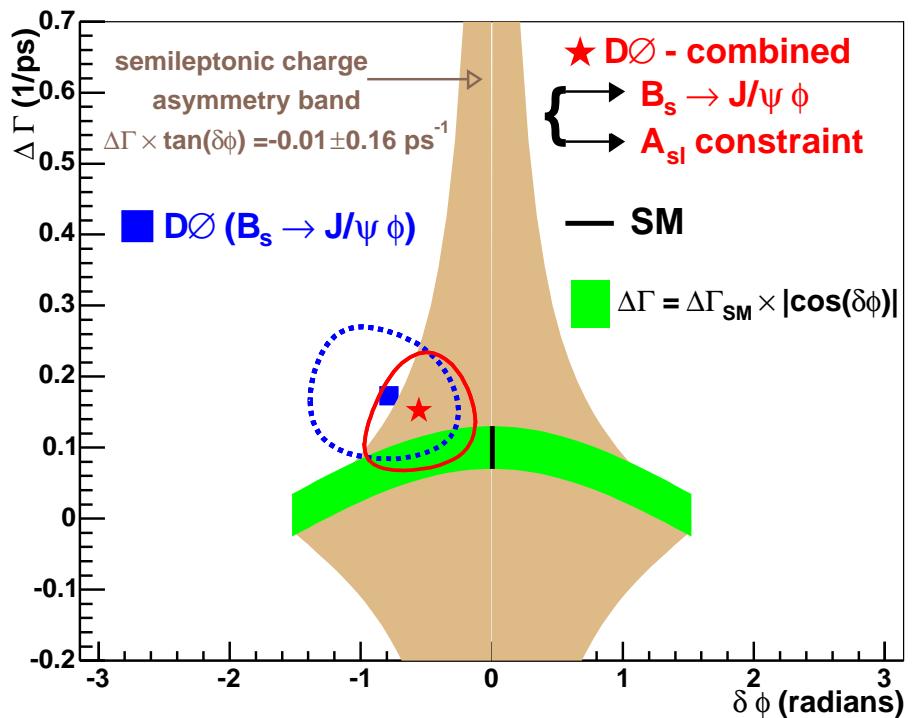
- Combine with time-integrated search for CP violation in untagged $B_s \rightarrow D_s(\phi\pi)\mu X$ decays

$$\Delta\Gamma_s = 0.15 \pm 0.08 \pm 0.03 \text{ ps}^{-1}$$

$$\phi_s = -0.56 \pm 0.40 \pm 0.01$$

- Consistent with SM (U. Nierste hep-ph/0406300)

$$\Delta\Gamma_s = 0.10 \pm 0.03 \text{ ps}^{-1}; \phi_s = -0.03 \pm 0.005$$



$B_s - \bar{B}_s$ Mixing

- First double sided limit on Δm_s (D0) (Phys. Rev. Lett. **97** (2006) 021802)
- First precision measurement of Δm_s (CDF) (Phys. Rev. Lett. **97**, (2006) 062003)
- Observation of Δm_s (CDF) (hep-ex/0609040)

Motivation

- Access to fundamental SM parameters

$$\Delta m_s = \frac{G_F^2 M_W^2 \eta S(m_t/m_W^2)}{6\pi^2} m_{B_s} f_{B_{B_s}}^2 |V_{ts}^* V_{tb}|^2$$

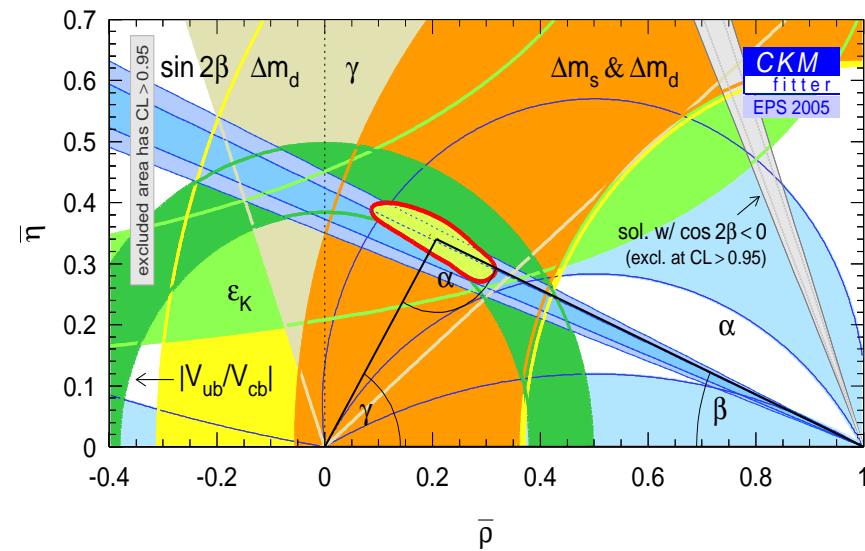
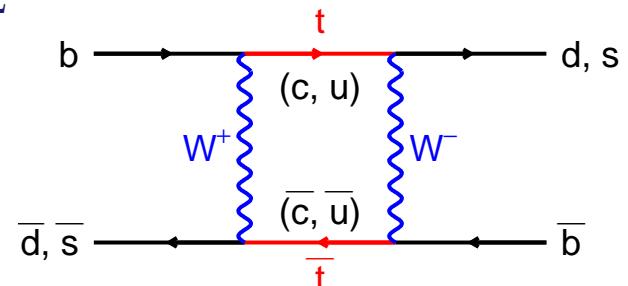
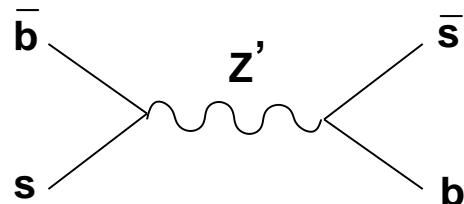
- Hadronic uncertainties cancel in ratio:

$$\frac{\Delta m_s}{\Delta m_d} = \frac{m_{B_s}}{m_{B_d}} \xi^2 \frac{|V_{ts}|^2}{|V_{td}|^2}$$

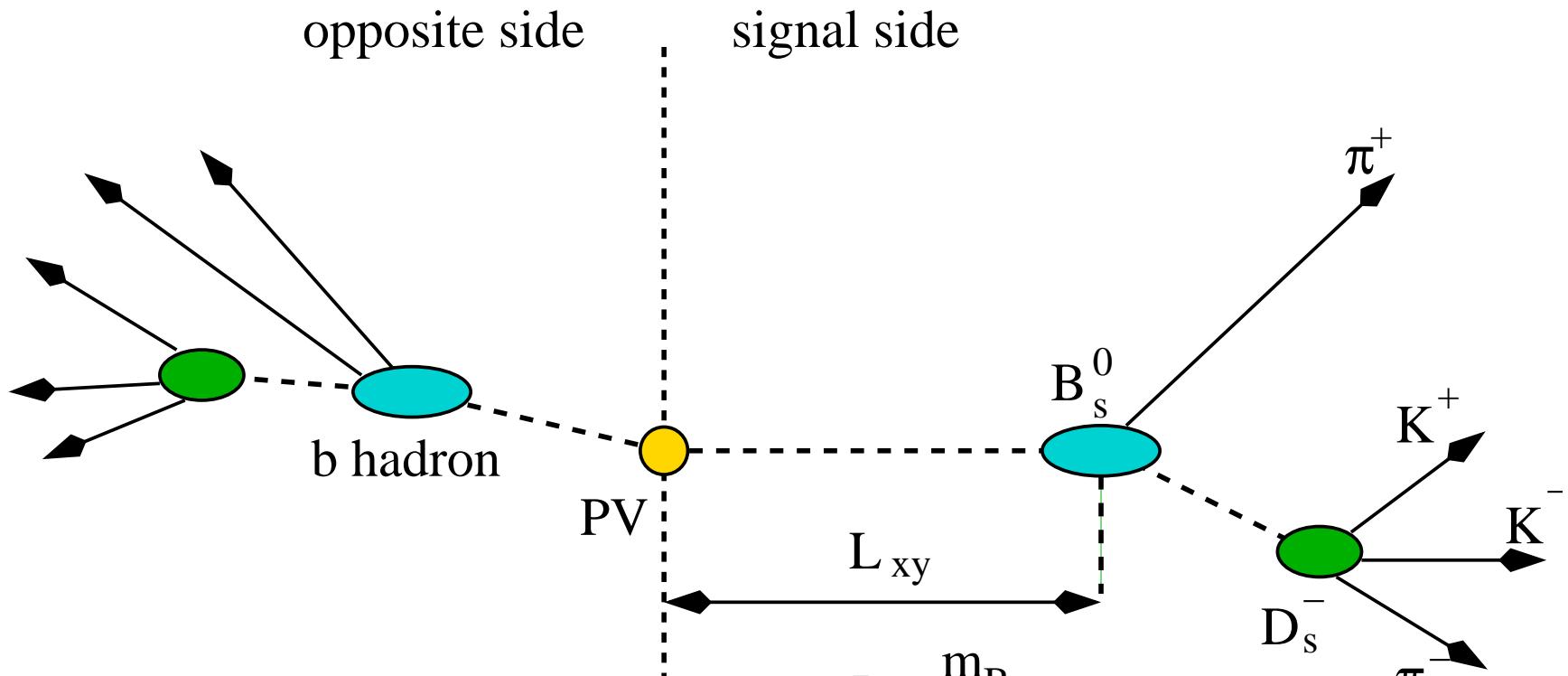
improved lattice (Okamoto, Lattice 05):

$$\xi = 1.21 \begin{array}{l} +0.047 \\ -0.035 \end{array}$$

- Prerequisite for time dependent CPV
- New Physics may affect $\Delta m_s/\Delta m_d$
E.g. new particles in loop, ...



$B_s^0 - \bar{B}_s^0$ Mixing Analysis



- 1) B_s selection & reconstruction
- 2) Measurement of proper decay time ct & ct resolution
- 3) Flavor tagging (main challenge at hadron colliders)

Time dependent asymmetry measurement:

$$\mathcal{A}(t) \equiv \frac{N(t)_{\text{unmixed}} - N(t)_{\text{mixed}}}{N(t)_{\text{unmixed}} + N(t)_{\text{mixed}}} = \mathcal{D} \cos(\Delta m_s t), \quad \mathcal{D} = 1 - 2P_{\text{mistag}}$$

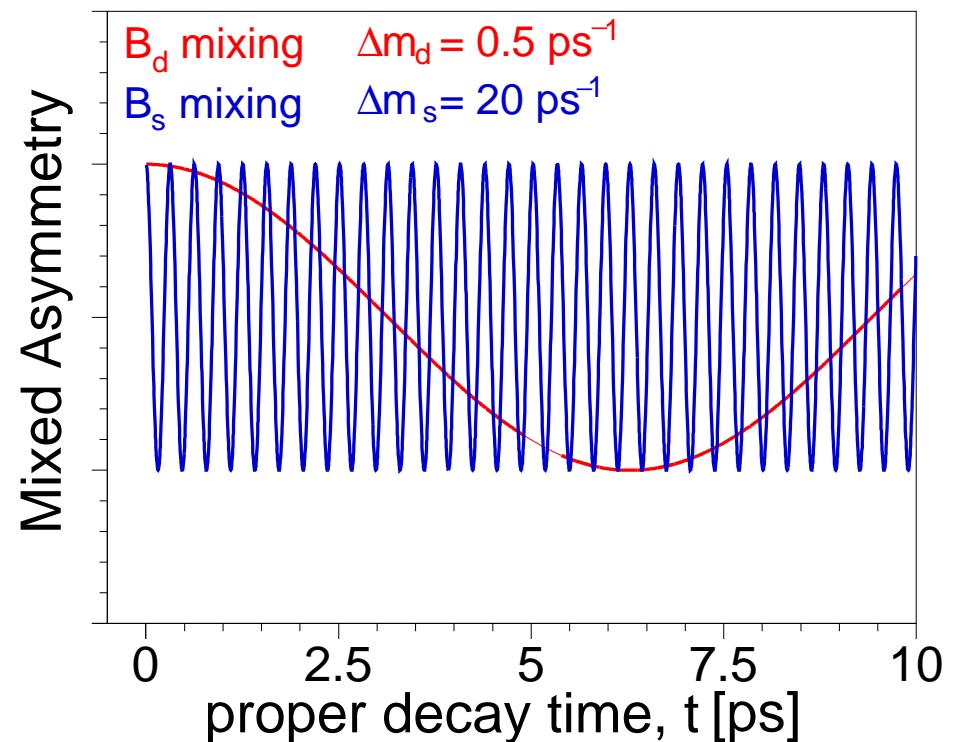
Why is it so difficult?

B_s Mixing is very very fast!

Challenges:

- Large statistics
- High vertex resolution
- High momentum resolution
- Good tagging

Very complex analysis!



For high Δm_s , $\sigma(ct)$ is crucial:

$$\text{significance} = \sqrt{\frac{S\epsilon D^2}{2}} \sqrt{\frac{S}{S+B}} e^{-\frac{(\Delta m_s \sigma_{ct})^2}{2}}$$

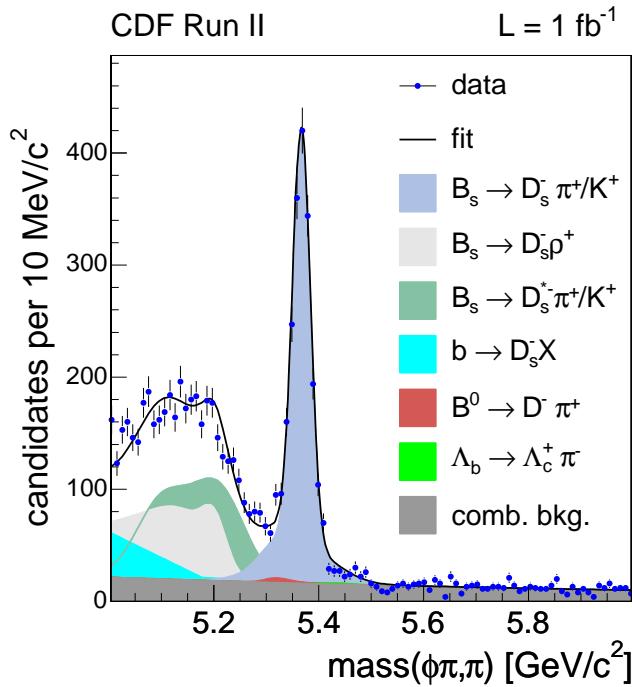
Signal Reconstruction

$$\sqrt{\frac{S\epsilon D^2}{2}} \sqrt{\frac{S}{S+B}} e^{-\frac{(\Delta m_s \sigma_{ct})^2}{2}}$$

Hadronic B_s Modes (CDF)

Hadronic Modes selected by Two Track Trigger

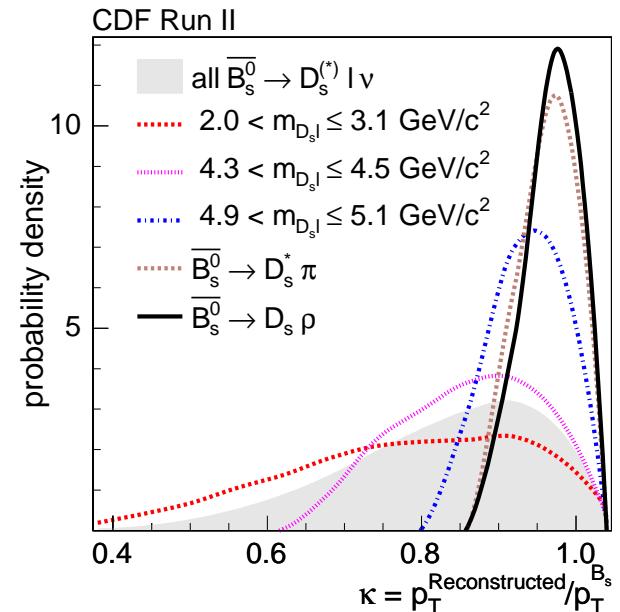
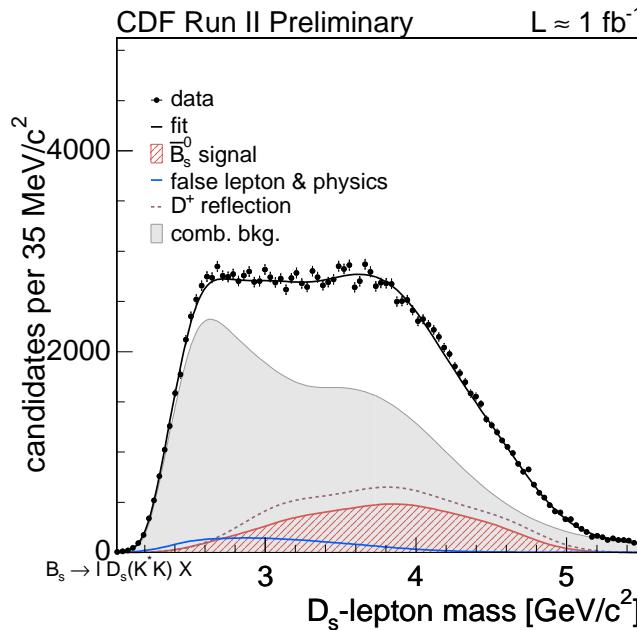
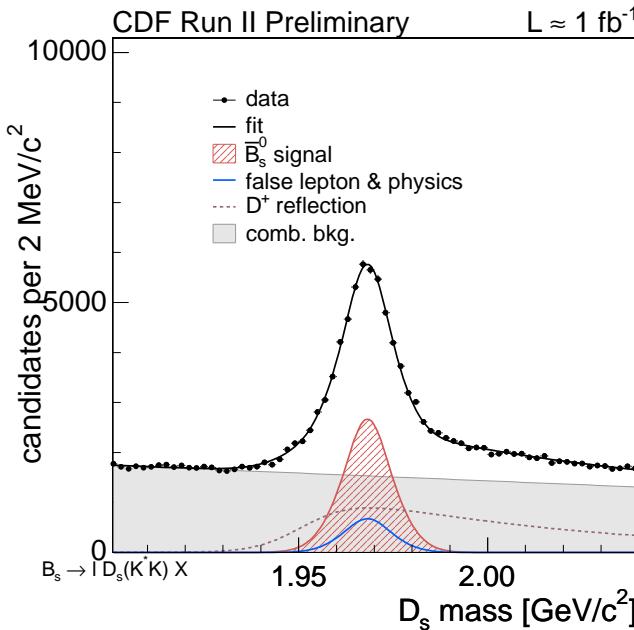
- 2000 fully reconstructed $B_s \rightarrow D_s(\phi\pi)\pi$ (golden mode)
- 3200 partially reconstructed $B_s \rightarrow D_s^*(\phi\pi)\pi$ and $B_s \rightarrow D_s^*(\phi\pi)\rho$ decays
slightly worse ct resolution due to lost γ or π^0
- 3600 fully reconstructed B_s candidates in add. modes



decay	#
$B_s \rightarrow D_s(\phi\pi)\pi$	1400
$B_s \rightarrow D_s(3\pi)\pi$	700
$B_s \rightarrow D_s(\phi\pi)3\pi$	700
$B_s \rightarrow D_s(K^* K)3\pi$	600
$B_s \rightarrow D_s(3\pi)3\pi$	200

NN for candidate selection

$B_s \rightarrow \ell D_s X$ Decays (CDF)



~ 61.500 semileptonic B_s candidates

High statistic, but worse ct -resolution:

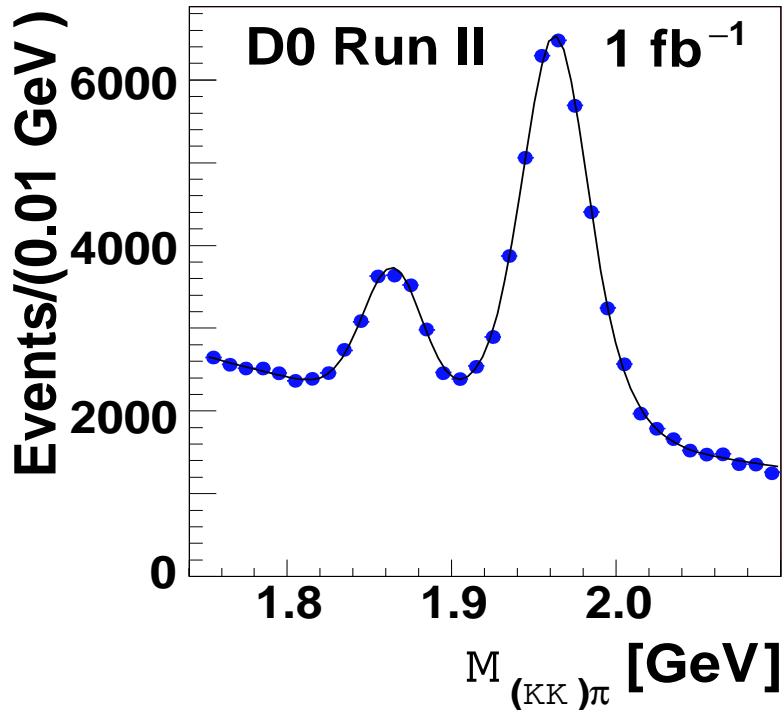
$$ct = \frac{L_{xy}}{\gamma\beta} = \frac{L_{xy}M(B)}{p_T(B)} = \frac{L_{xy}M(B)}{p_T(\ell D)} * K \text{ (K from Monte Carlo);}$$

$$\sigma_{ct} = \sqrt{\left(\frac{\sigma_{L_{xy}}}{\gamma\beta}\right)^2 + \left(\frac{\sigma_{\gamma\beta}}{\gamma\beta} * ct\right)^2}$$

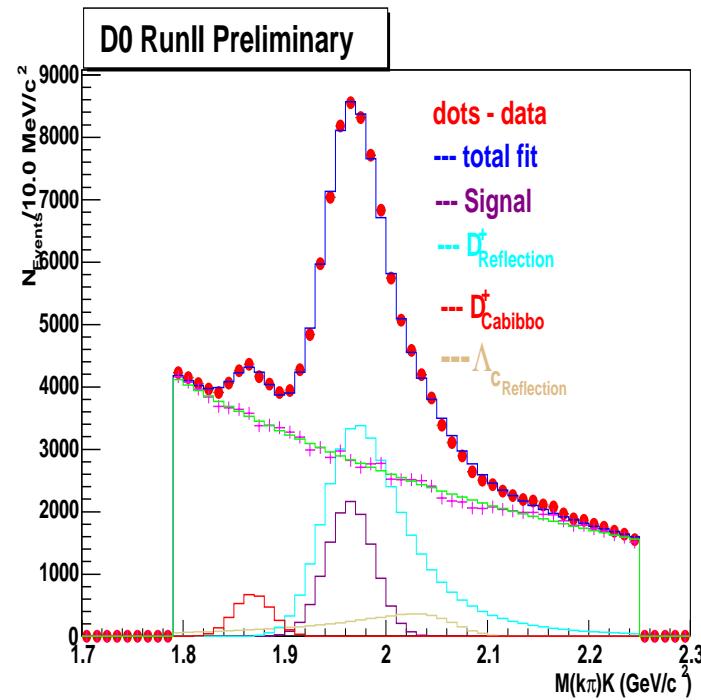
Sensitivity driven by high ℓD mass candidates \rightarrow exploit in the fit

B_s Decays (D0)

Large statistic in semi-muonic decays



~ 27.000 $B_s \rightarrow \mu D_s(\phi\pi)X$
& ~ 2.000 $B_s \rightarrow e D_s(\phi\pi)X$



~ 12.600 $B_s \rightarrow \mu D_s(K^* K)X$

Plan: trigger muon as opposite side tag + fully reconstructed B_s candidate on the other side

Proper Decay Time Resolution

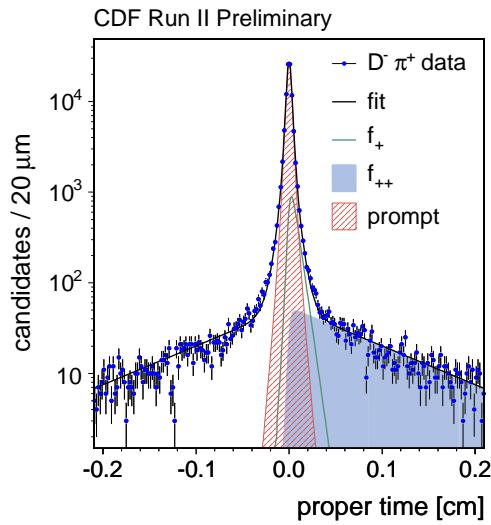
$$\sqrt{\frac{S\epsilon D^2}{2}} \sqrt{\frac{S}{S+B}} e^{-\frac{(\Delta m_s \sigma_{ct})^2}{2}}$$

Proper Time Resolution

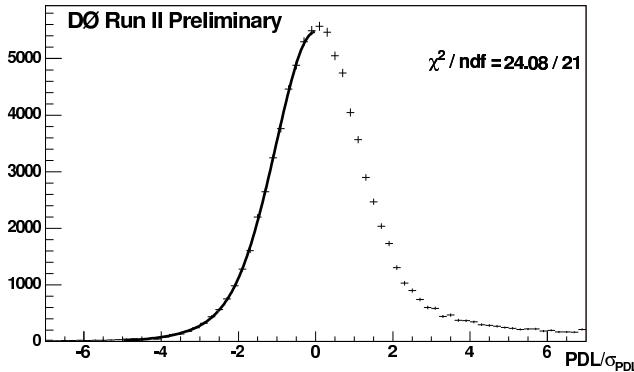
Critical aspect of the analysis, limiting factor at high Δm_s

σ_{ct} is determined from data

CDF: prompt D + track(s)
mimics B decay topology



D0: prompt J/Ψ



Mode	$\langle \sigma(ct) \rangle [\mu\text{m}]$
$B_s \rightarrow D_s(3)\pi$ (CDF)	26
$B_s \rightarrow \ell D_s X$ (CDF)	45
$B_s \rightarrow \mu D_s X$ (D0)	50-60*

$$(\Delta m_s = 18 \text{ ps}^{-1} \approx 100 \mu\text{m})$$

* Add. silicon layer currently being commissioned

+ exploit event-by-event predicted resolution, take into account dependence on several variables: isolation, vertex χ^2 , ...

Flavor Tagging

$$\sqrt{\frac{S\epsilon D^2}{2}} \sqrt{\frac{S}{S+B}} e^{-\frac{(\Delta m_s \sigma_{ct})^2}{2}}$$

Opposite Side Tagging

B mesons produced in pairs \rightarrow production flavors correlated

- **Jet Charge Tagging** (high efficiency, low purity)
Weighted sum of fragmentation and decay tracks of the opposite side B

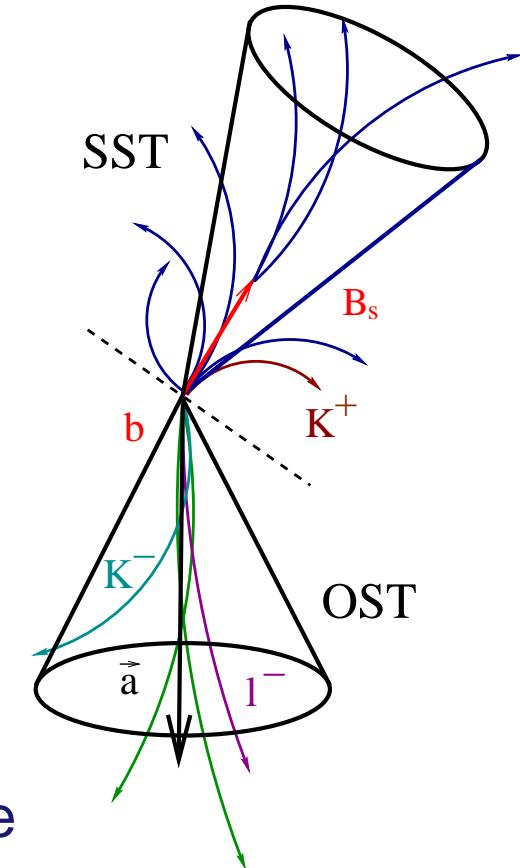
- **Lepton Tagging** (high purity, low efficiency)
Semileptonic decay of opposite side B
($\approx 20\%$ B 's mix before the decay)

- **Kaon Tagging** (high efficiency, low purity)
Favored transition: $b \rightarrow c \rightarrow s$

Often opposite side B not in detector acceptance

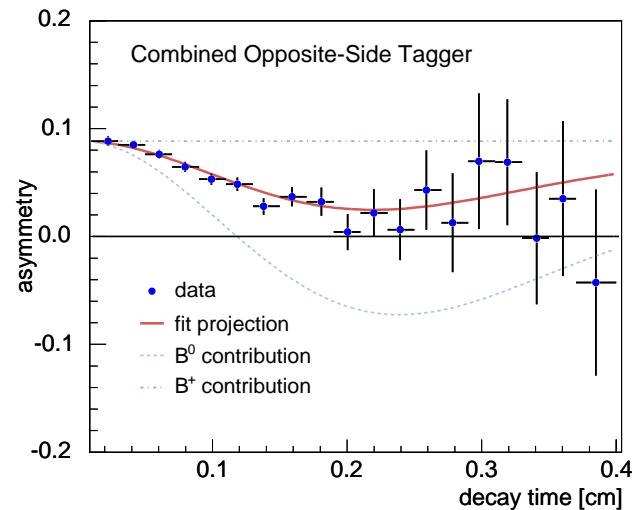
Additional gain in tagging performance:

- + Classification of events (dilution parameterization)
- + Combination of all opposite side tagging information



OST in B^+ & B_d

- Important test of the fitter (complex unbinned likelihood fit)
- Calibration of opposite side taggers
(opposite side B independent of signal side)

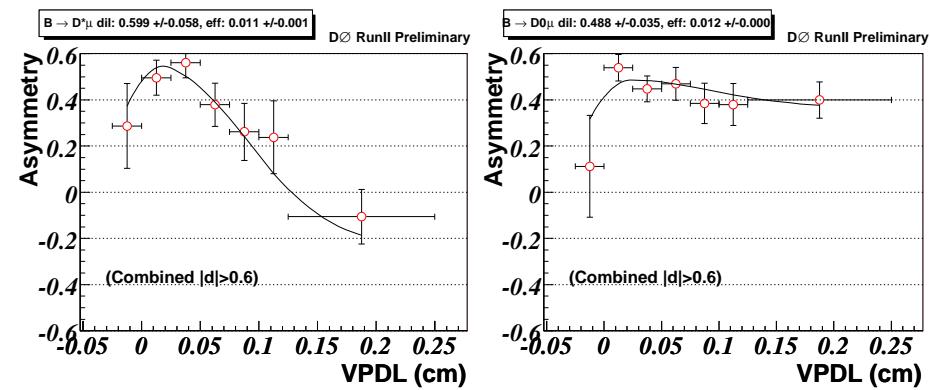
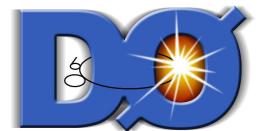


$$\epsilon D^2 = 1.8 \%$$

$$\Delta m_d = 0.509 \pm 0.010 \pm 0.016 \text{ ps}^{-1}$$

$$\epsilon D^2 = 2.5 \%$$

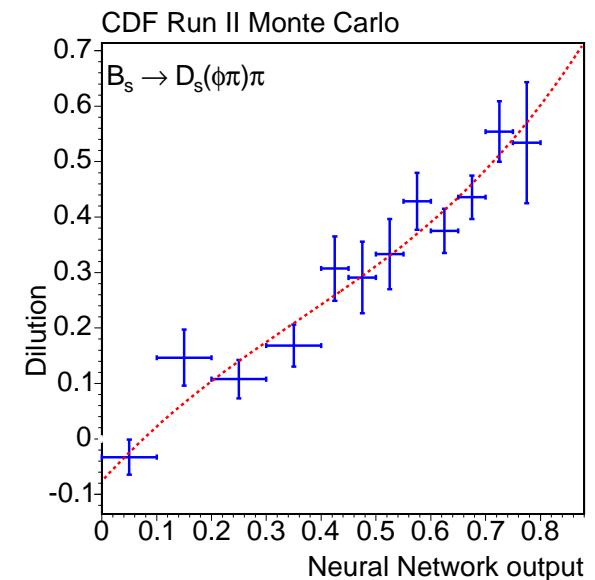
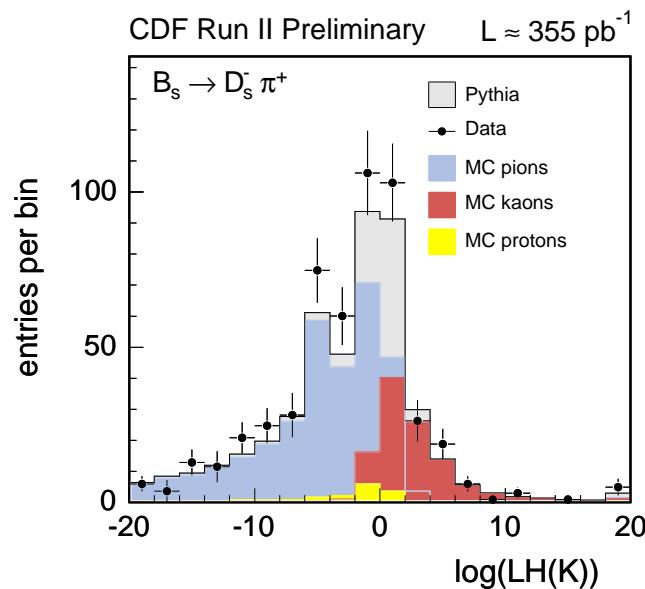
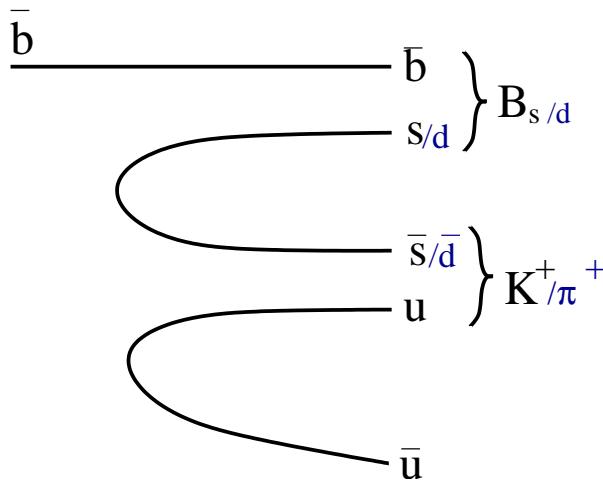
$$\Delta m_d = 0.506 \pm 0.020 \pm 0.016 \text{ ps}^{-1}$$



$$\Delta m_d \text{ (PDG)} = 0.507 \pm 0.005 \text{ ps}^{-1}$$

to be compared with $\epsilon D^2 \approx 30\%$ from B factories

Same Side Tagger @ CDF



- Charge of closest fragmentation track correlated to B production flavor
- SSKT performance can NOT be determined on data
Understanding of Monte Carlo (PYTHIA) crucial!

Final algorithm: NN combination of kaon probability and kinematical variables

ϵD^2 (hadronic modes) = 3.5 %; ϵD^2 (semileptonic modes) = 4.8 %

Tagging performance enlarged by $\times 3\text{-}4$!

Analysis Methods & Results

Fourier Analysis

Two domains to fit for oscillation:

Time domain:

- Fit for Δm_s in

$$P(t) \sim (1 \pm D \cos \Delta m_s t)$$

Frequency domain: amplitude scan

- Introduce amplitude:

$$P(t) \sim (1 \pm \mathcal{A} D \cos \Delta m_s t)$$

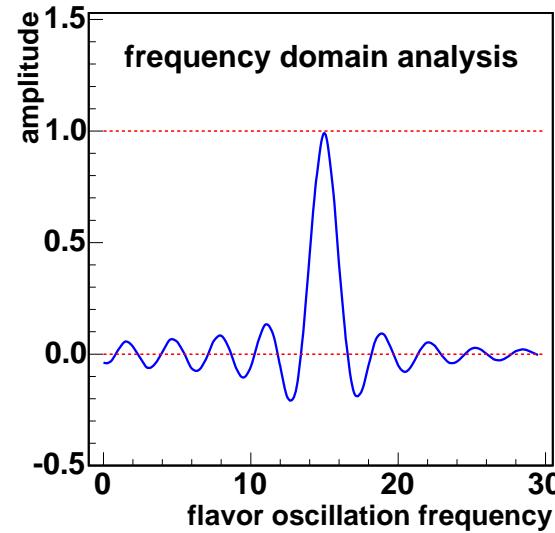
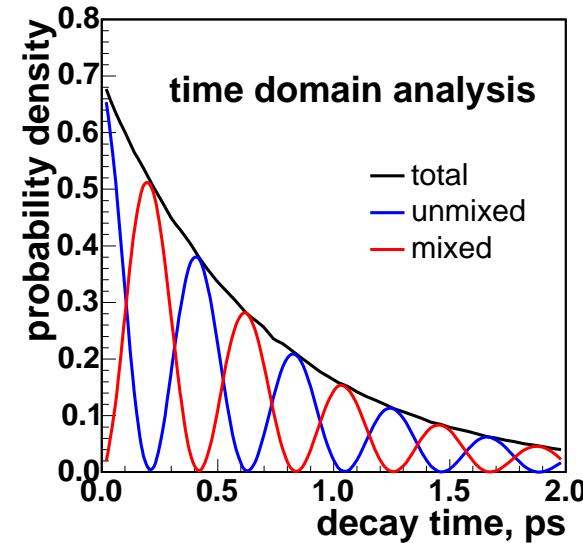
- Fit for \mathcal{A} at different Δm_s

⇒ Obtain frequency spectrum

- True $\Delta m_s \Rightarrow \mathcal{A} = 1$, else $\mathcal{A} = 0$

- Traditionally used for B_s mixing search

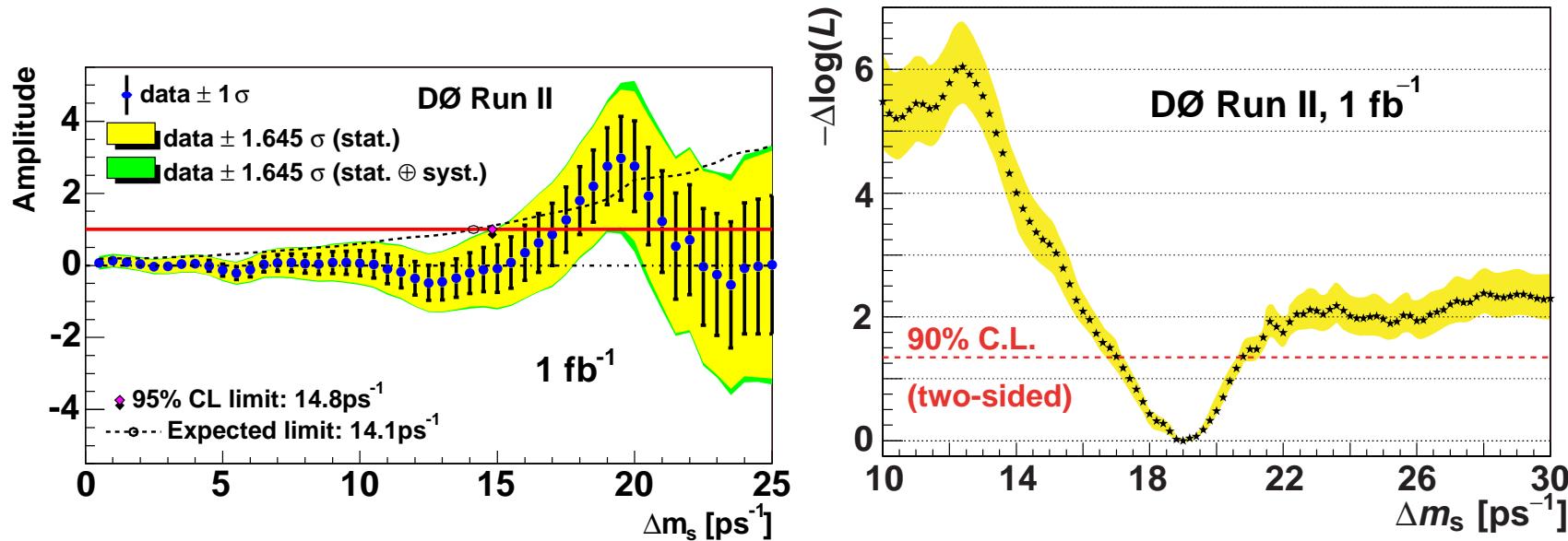
⇒ Easy to combine experiments



Published D0 Result

based on $B_s \rightarrow D_s(\phi\pi)\mu X$ sample (Phys. Rev. Lett. **97** (2006) 021802)

One experiment sets same exclusion limit as all combined ones!



First double sided limit: $17 < \Delta m_s < 21 \text{ ps}^{-1}$ @ 90% CL

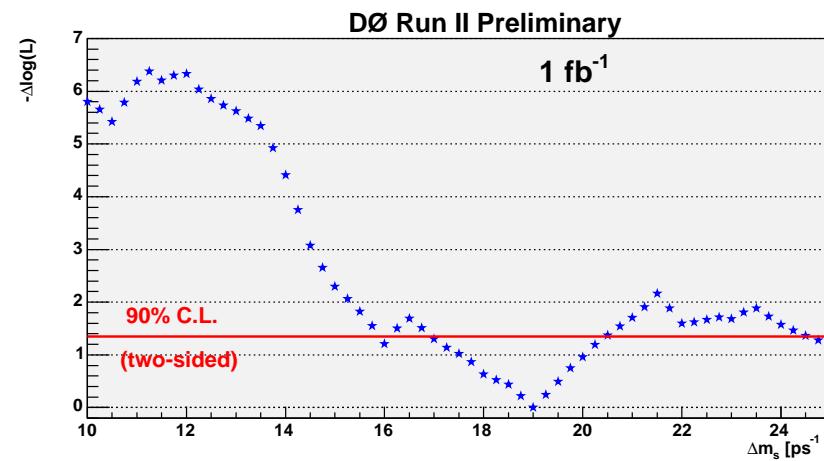
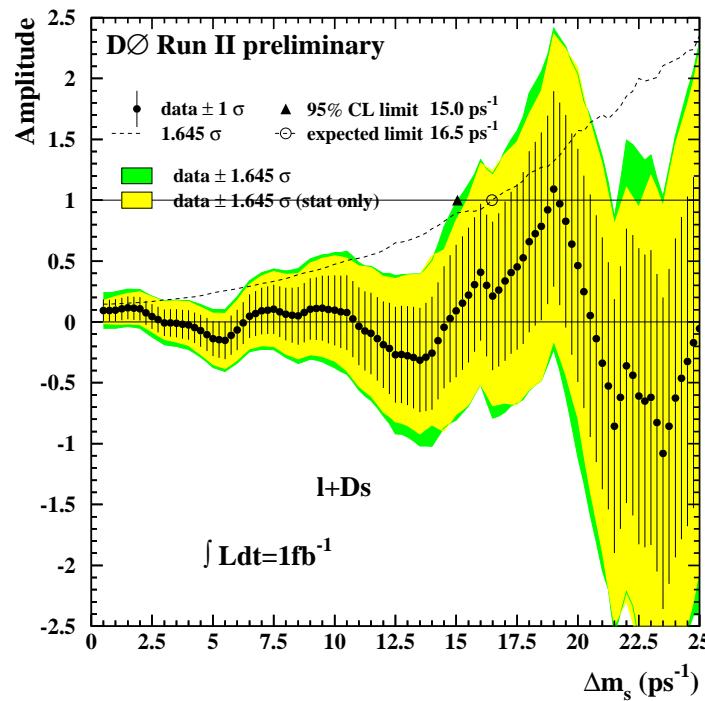
$\Delta m_s < 21 \text{ ps}^{-1}$ @ 95% CL

false probability at 17-21 ps⁻¹ $\approx 5\%$

Updated D0 Result

include additionally $B_s \rightarrow D_s(K^*K)\mu X$ & $B_s \rightarrow D_s(\phi\pi)eX$

Amplitude consistent with 1 around $\Delta m_s = 19 \text{ ps}^{-1}$



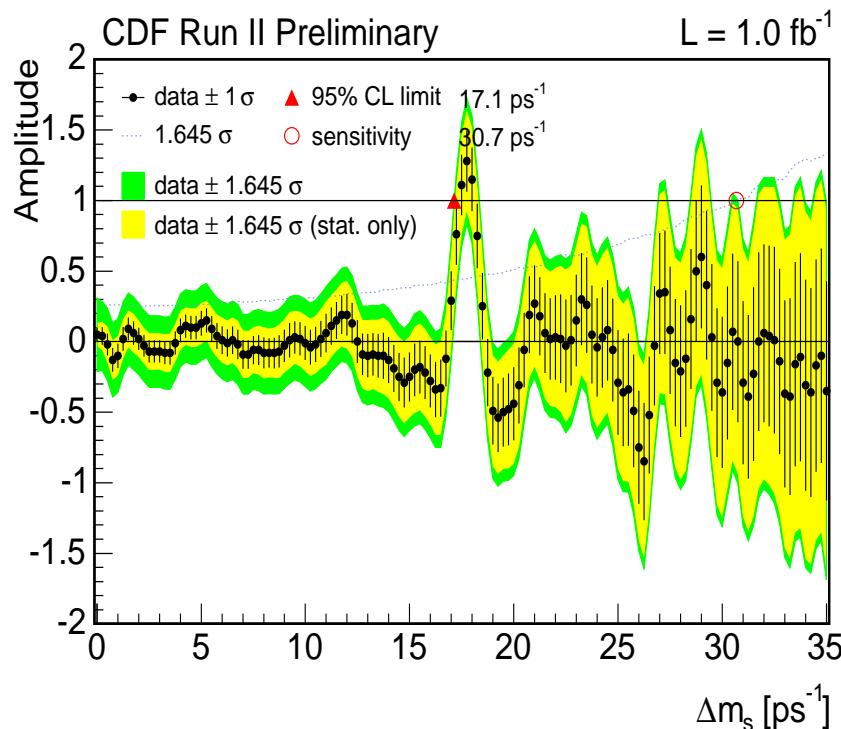
double sided 90% CL limit: $17 < \Delta m_s < 21 \text{ ps}^{-1}$

$\Delta m_s > 15 \text{ ps}^{-1}$ @ 95% CL

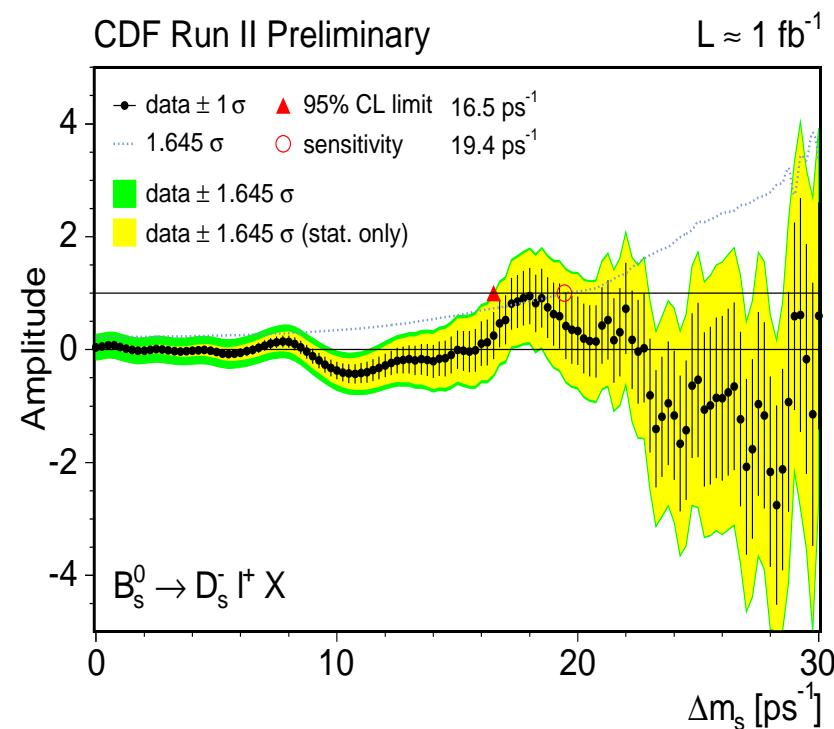
false probability at 17-21 ps^{-1} $\approx 8.0\%$

Amplitude Scans (CDF)

hadronic



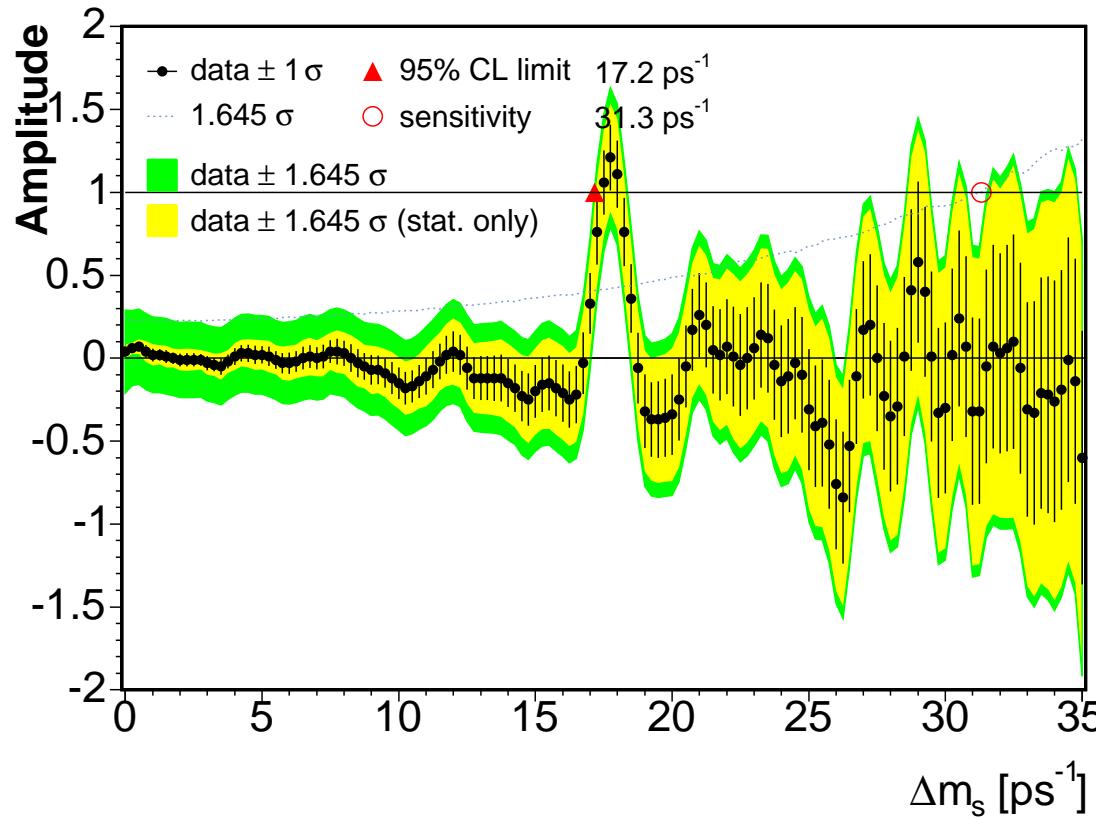
semileptonic



\mathcal{A} consistent with 1 for $\Delta m_s \sim 17.75 \text{ ps}^{-1}$ for both samples
Hadronic sensitivity $\geq 30 \text{ ps}^{-1}$!

Combined Amplitude Scan (CDF)

\mathcal{A} compatible with 1 for $\Delta m_s \sim 17.75 \text{ ps}^{-1}$!

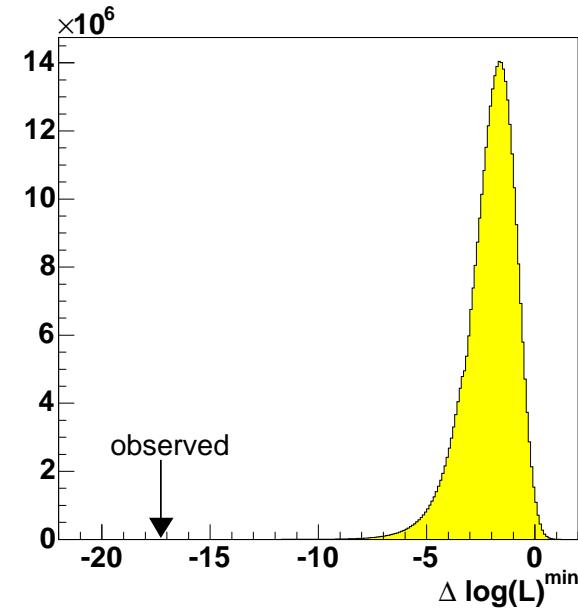
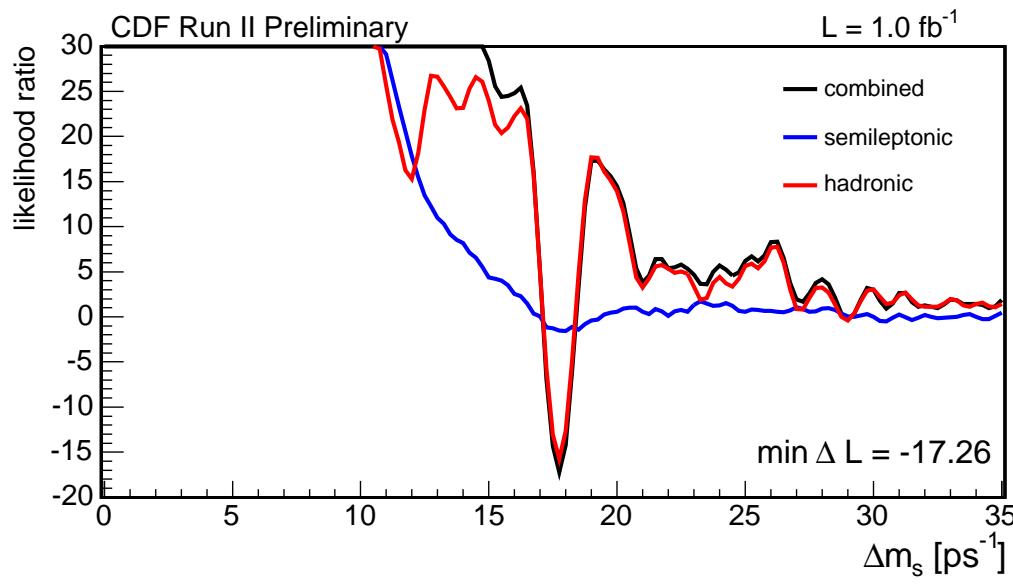


$$\mathcal{A}/\sigma_{\mathcal{A}}(\Delta m_s = 17.75 \text{ ps}^{-1}) \sim 6.05$$

What is the probability for background to fake such a signal?

Likelihood Scan (CDF)

Figure of merit: $\log(L) = \log[L(A = 1, \Delta m_s)/L(A = 0)]$



How often can random tags produce a LH minimum this deep?

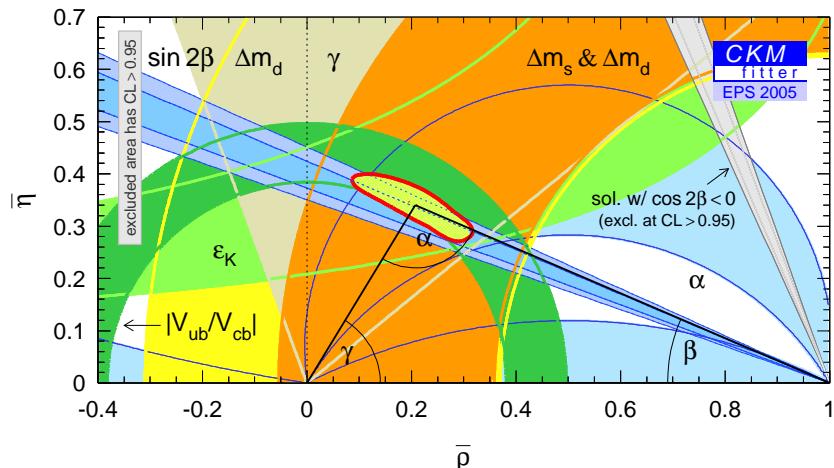
P-value: 8×10^{-8} ; we are in 5 σ land!

$$\Delta m_s = 17.77 \pm 0.10(\text{stat.}) \pm 0.07(\text{syst.}) \text{ ps}^{-1}$$

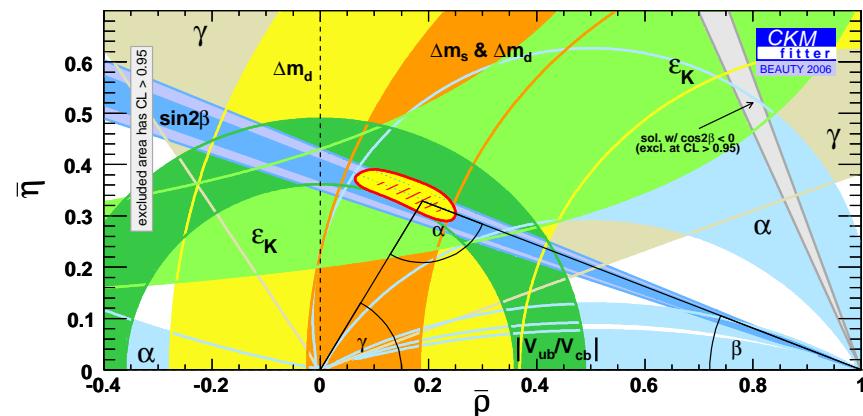
Systematic dominated by uncertainties on ct scale
consistent with indirect SM fits: $\Delta m_s = 18.3^{+6.5}_{-1.5} \text{ ps}^{-1}$

$|V_{td}|/|V_{ts}|$ Measurement (CDF)

status summer 05

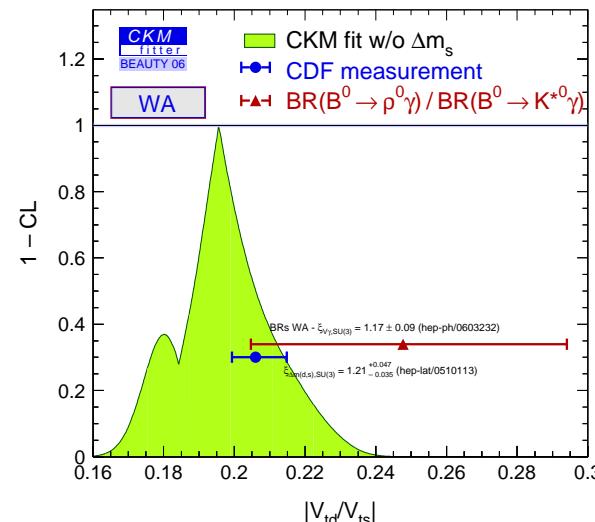
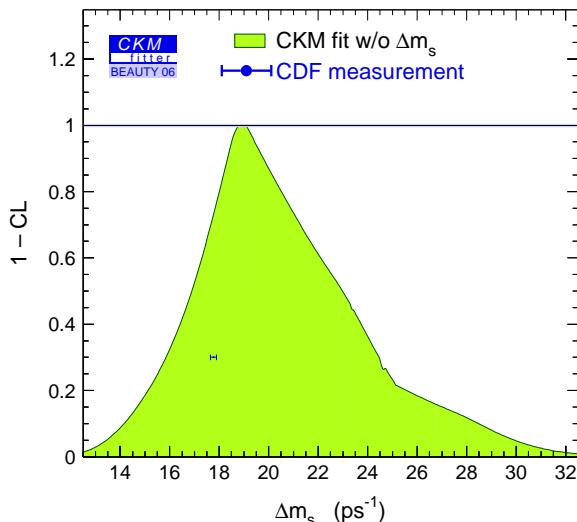


status autumn 06



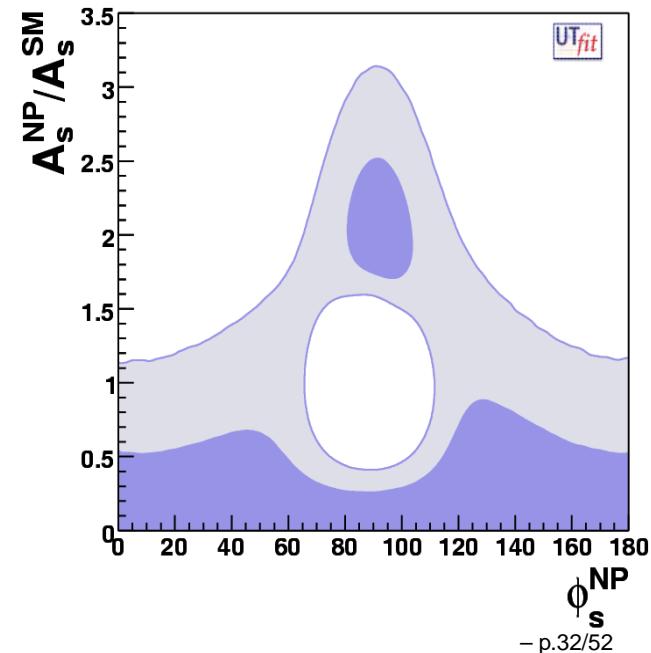
$$|V_{td}|/|V_{ts}| = 0.2061 \pm 0.0007(\text{exp.})^{+0.0081}_{-0.0060}(\text{theo.})$$

Measurement no longer determined by experimental uncertainties



Summary

- Tevatron significantly improved understanding of B_s physics
- Precision measurements on $\Delta\Gamma_s$
 $\Delta\Gamma_s = 0.12 \pm 0.08 \pm 0.03 \text{ ps}^{-1}$
(and first look at CP violating phase)
- First measurement of Δm_s :
 $17.77 \pm 0.10(\text{stat.}) \pm 0.07(\text{syst.}) \text{ ps}^{-1}$
Signal at 5σ level & seen by both experiments!
- CDF & D0 keep on testing the Standard Model
and constraining New Physics Models

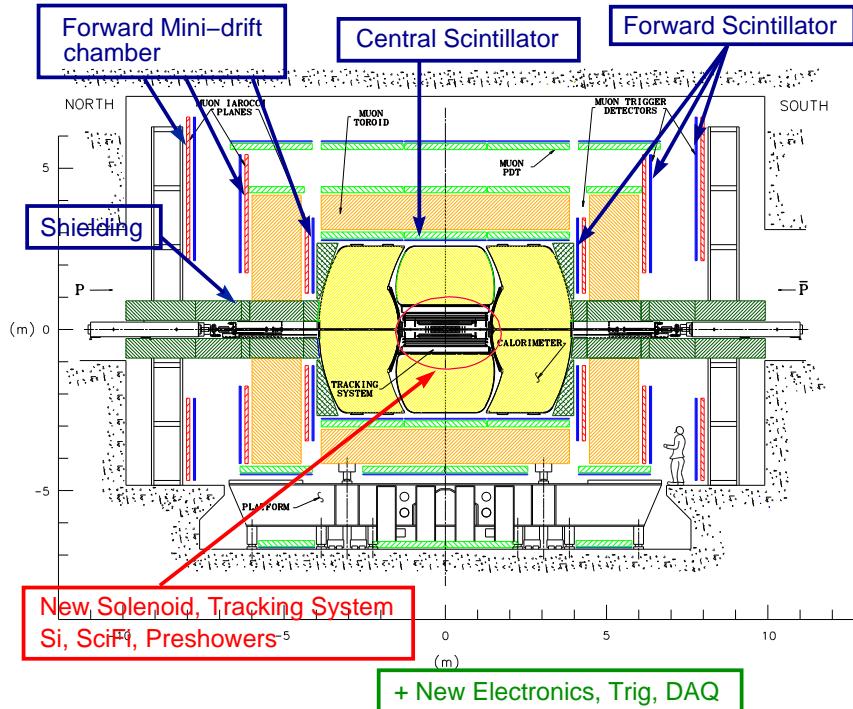
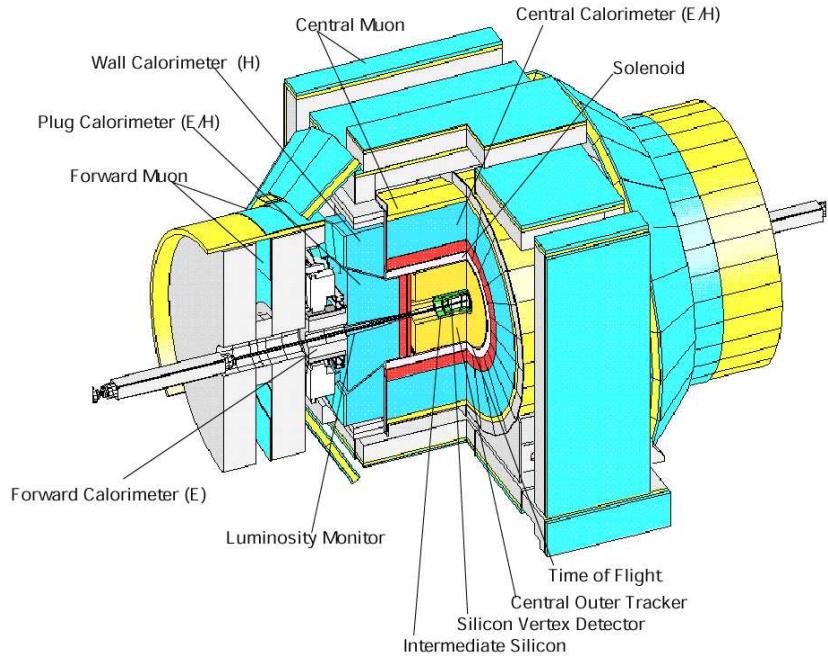


Backup

CDF versus D0

CDF

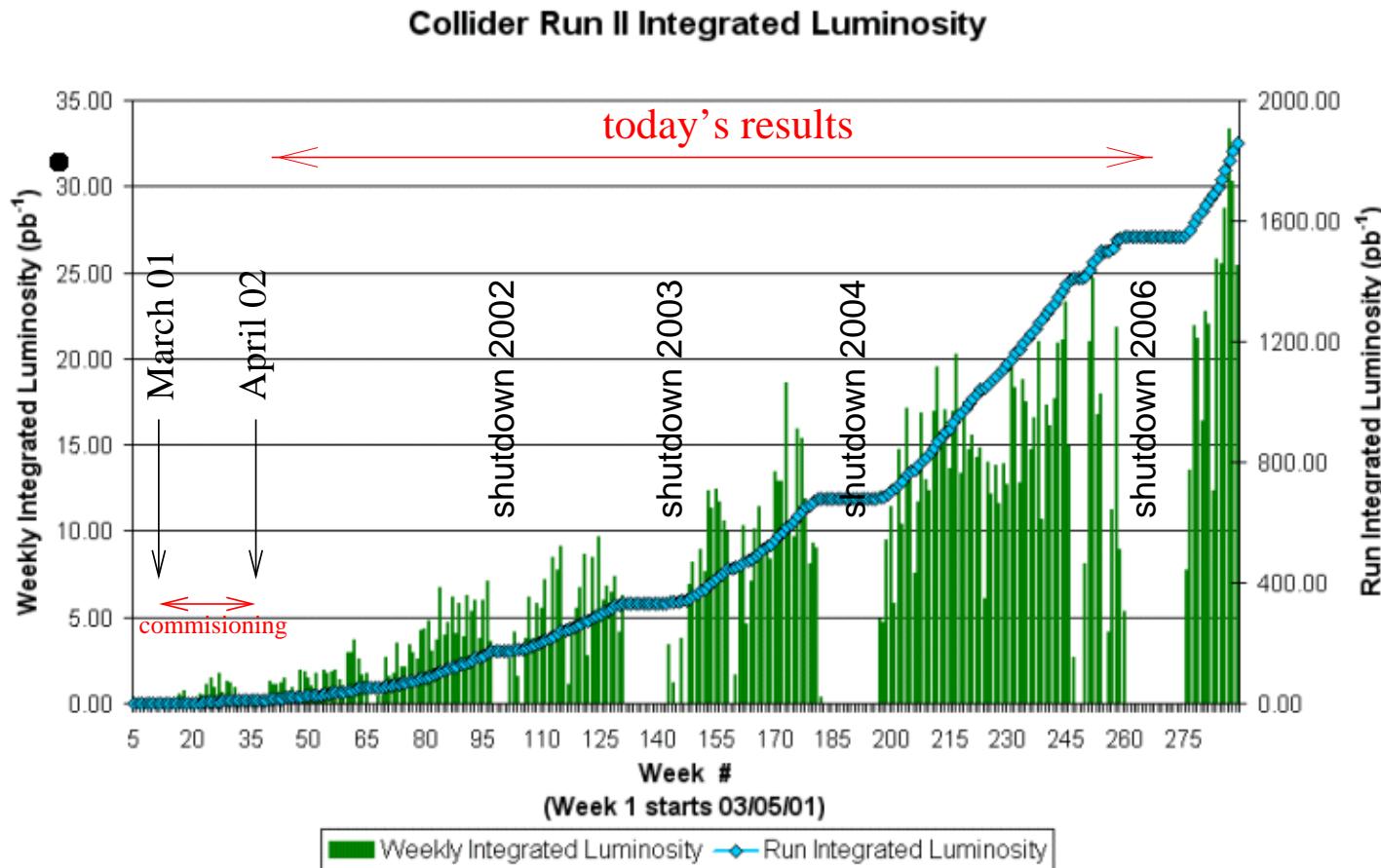
- Two displaced Track Trigger (TTT)
- Particle ID (dE/dx & TOF)
- Silicon layer close to interaction
strong in hadronic decays
good kaon tagging



D0

- Excellent Muon coverage
 - High forward acceptance
- strong in semi-muonic decays
excellent muon tagging

Tevatron Performance



Delivered luminosity (2002 - now): 1.8 fb^{-1} , (on tape: 1.6 fb^{-1})

Used for following analysis: 1 fb^{-1} ; (unless explicitly stated)

Short Reminder on CKM Physics

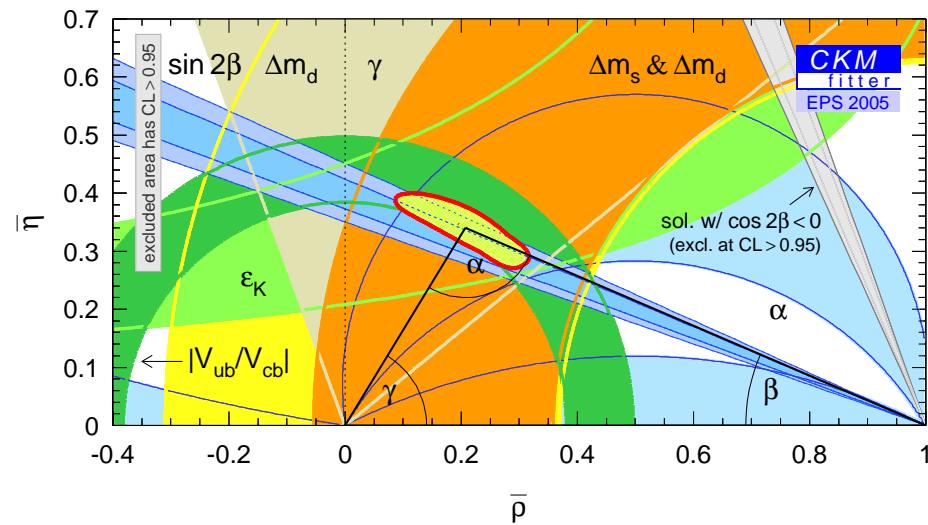
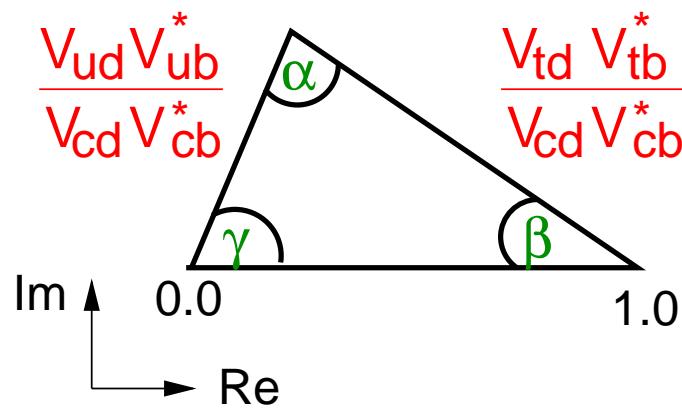
Our knowledge of flavor physics can be expressed in the CKM matrix basis transformation between mass (strong) and flavor (weak) eigenstates

$$V_{CKM} = \begin{pmatrix} V_{ud} & V_{us} & V_{ub} \\ V_{cd} & V_{cs} & V_{cb} \\ V_{td} & V_{ts} & V_{tb} \end{pmatrix} = \begin{pmatrix} 1 - \lambda^2/2 & \lambda & A\lambda^3(\rho - i\eta) \\ -\lambda & 1 - \lambda^2/2 & A\lambda^2 \\ A\lambda^3(1 - \rho - i\eta) & -A\lambda^2 & 1 \end{pmatrix} + O(\lambda^4)$$

3 real parameters & one complex phase $\rightarrow CP$ violation $\lambda \approx 0.22$

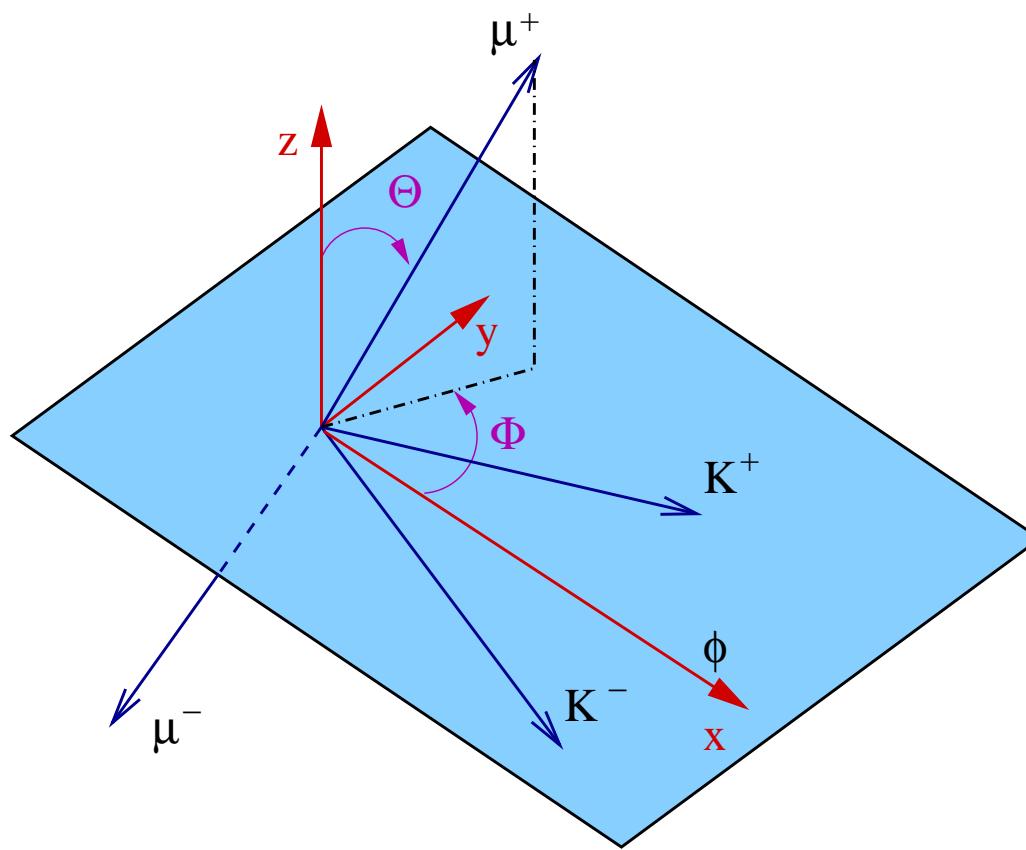
Unitarity relation for b quarks:

$$V_{ud}V_{ub}^* + V_{cd}V_{cb}^* + V_{td}V_{tb}^* = 0$$



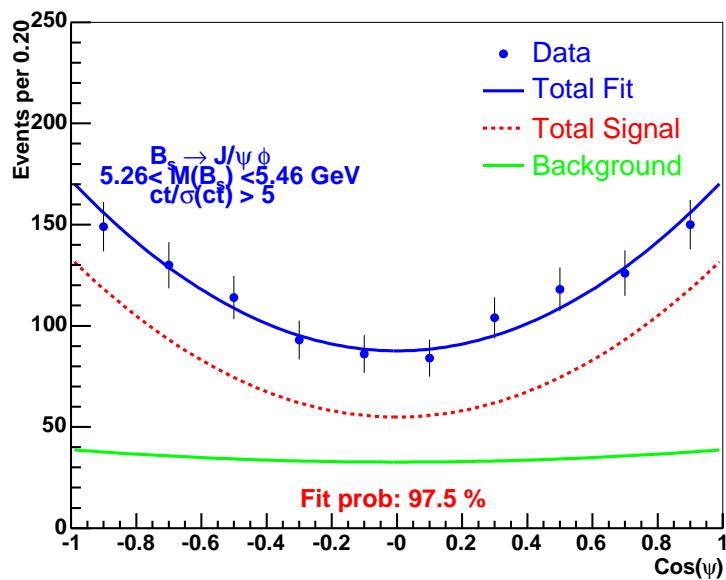
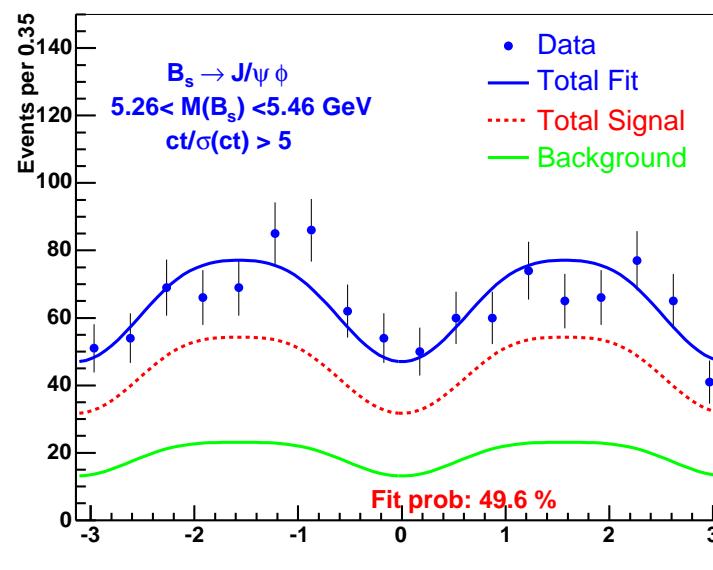
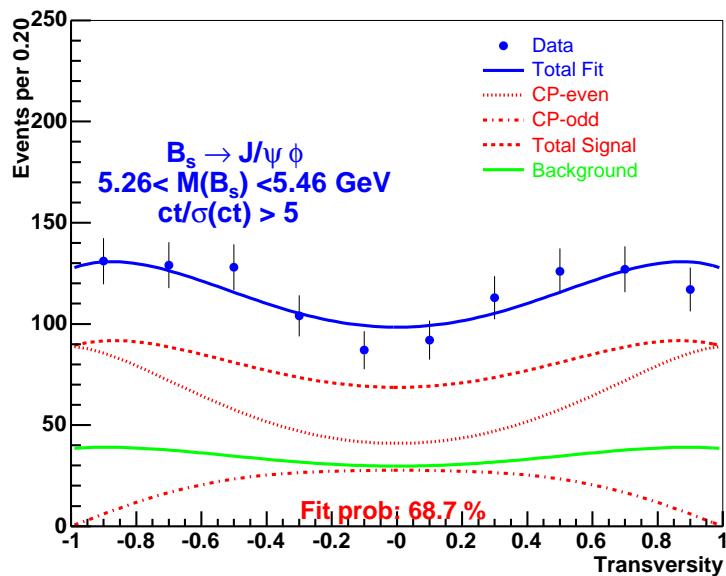
Many constraints on CKM parameters come from B system

Transversity Base

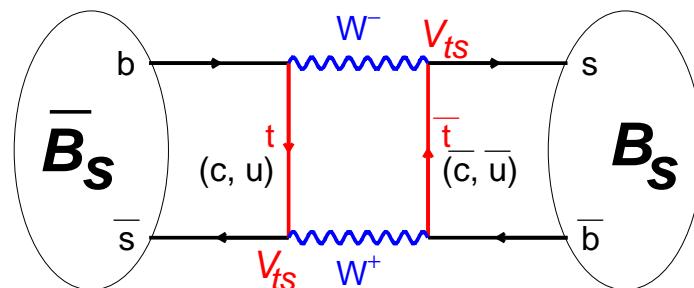
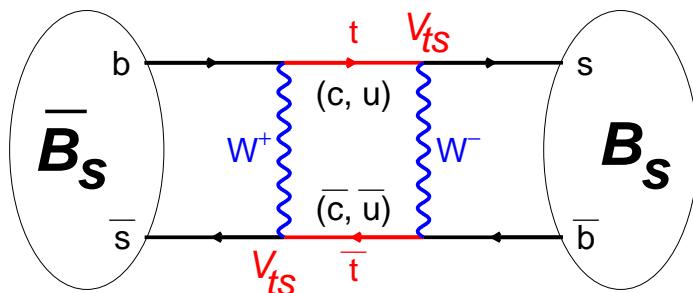


- work in J/ψ rest frame
- K^+K^- plane defines x/y plane, K^+ defines positive y axis
- θ, ϕ polar and azimuthal angle of μ^+
- Ψ helicity angle of ϕ

$\Delta\Gamma_s$: Angular Distributions



Neutral B Meson Mixing



Two-state mixing system

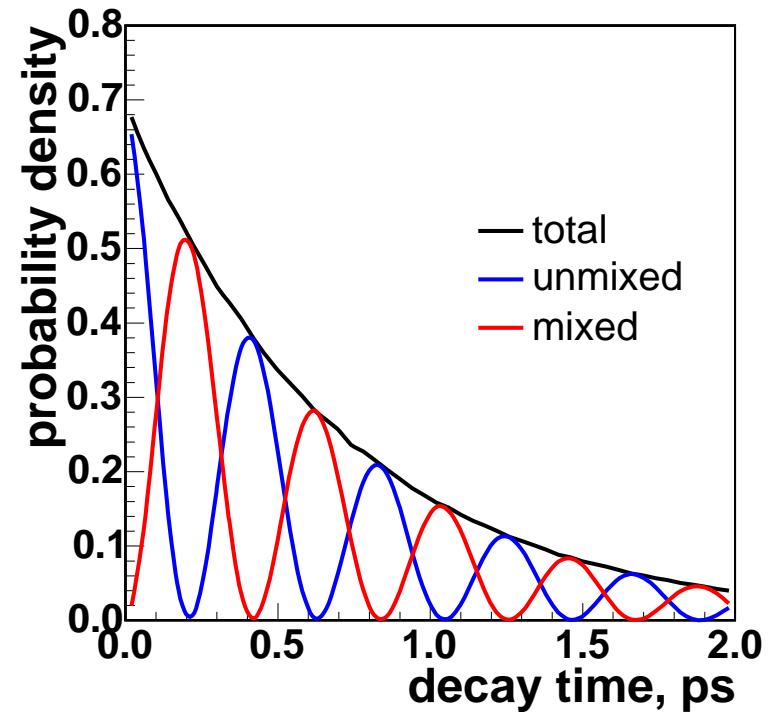
- “heavy” and “light” mass eigenstates
- B and \bar{B} weak eigenstates:

$$|B_s^0\rangle = \frac{1}{\sqrt{2}}(|B_{s,H}\rangle + |B_{s,L}\rangle)$$

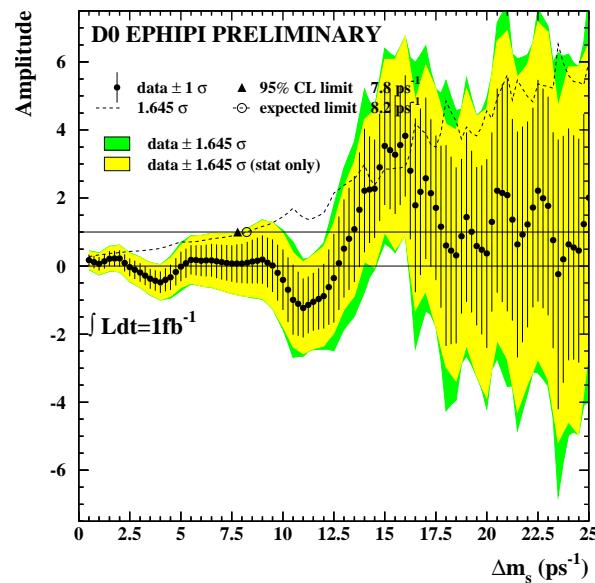
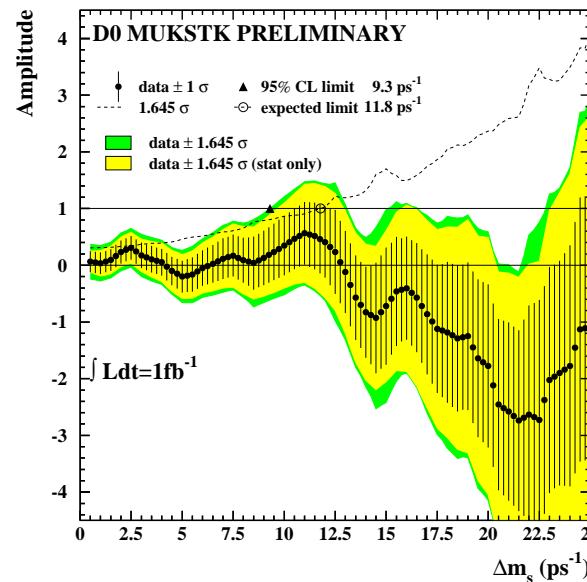
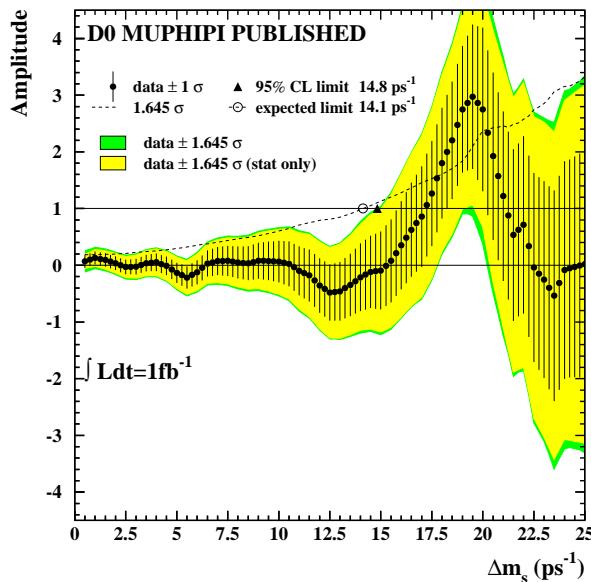
$$|\bar{B}_s^0\rangle = \frac{1}{\sqrt{2}}(|B_{s,H}\rangle - |B_{s,L}\rangle)$$
- Solution in proper time

$$P(t)_{B_s^0 \rightarrow B_s^0} = \frac{1}{2\tau} e^{-t/\tau} (1 + \cos \Delta m_s t)$$

$$P(t)_{B_s^0 \rightarrow \bar{B}_s^0} = \frac{1}{2\tau} e^{-t/\tau} (1 - \cos \Delta m_s t)$$
- mixing frequency $\Delta m_s = m_H - m_L$



Mixing Results (D0)



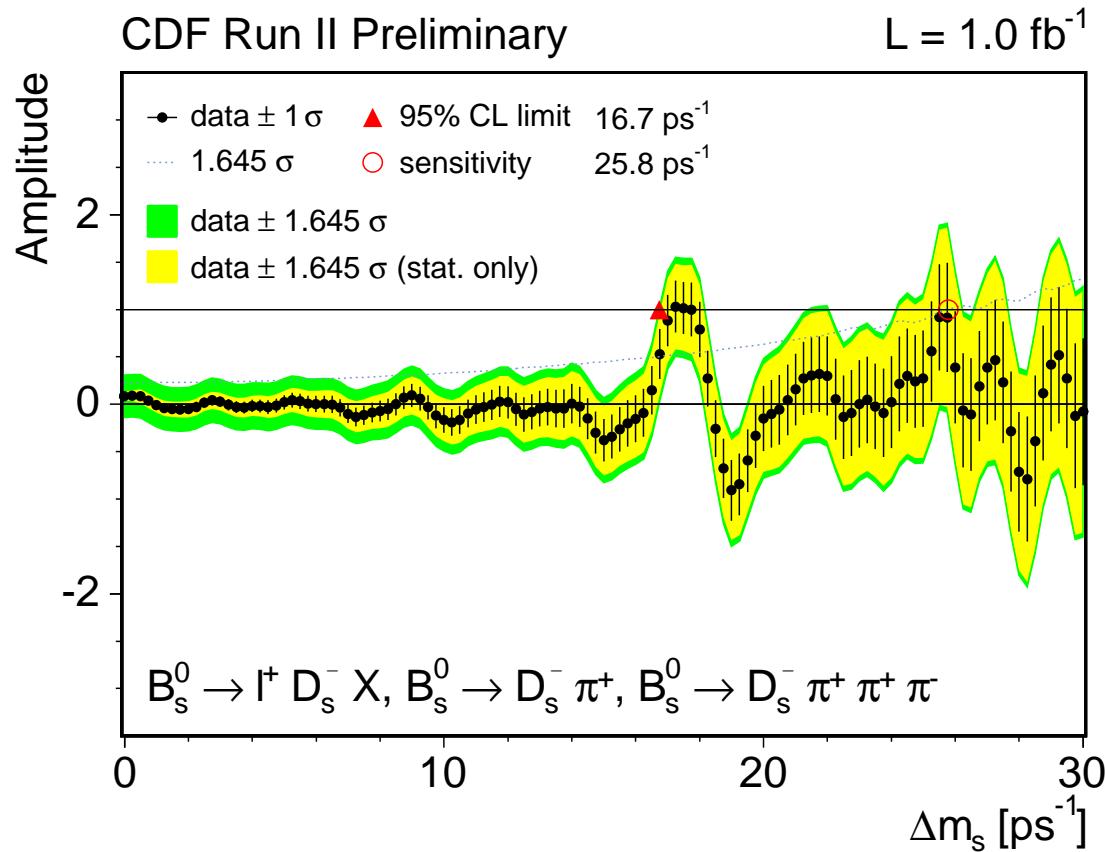
Update of Δm_s Analysis (CDF)

- partial reconstructed golden modes (+ 3.200 B_s candidates)
- NN selection for additional hadronic modes
(2.100 → 3.600 B_s candidates & better S/N)
- improvement in tagging performance:
 - addition of opposite side kaon tagger
 - NN combination of opposite side taggers
 - combination of kinematical and PID variables for SST
- PID selection for semileptonic modes, $m(\ell D)$ included in fit

False probability went down from 0.5×10^{-2} to 8×10^{-8} on the same data sample!

Spring '06 Result (CDF)

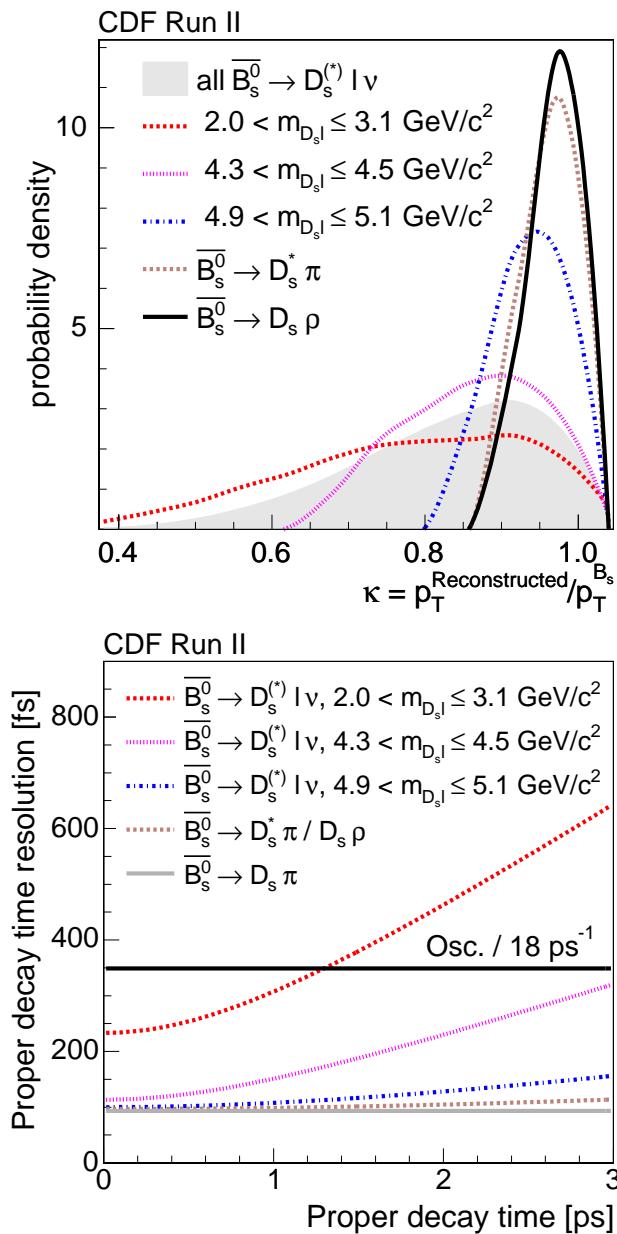
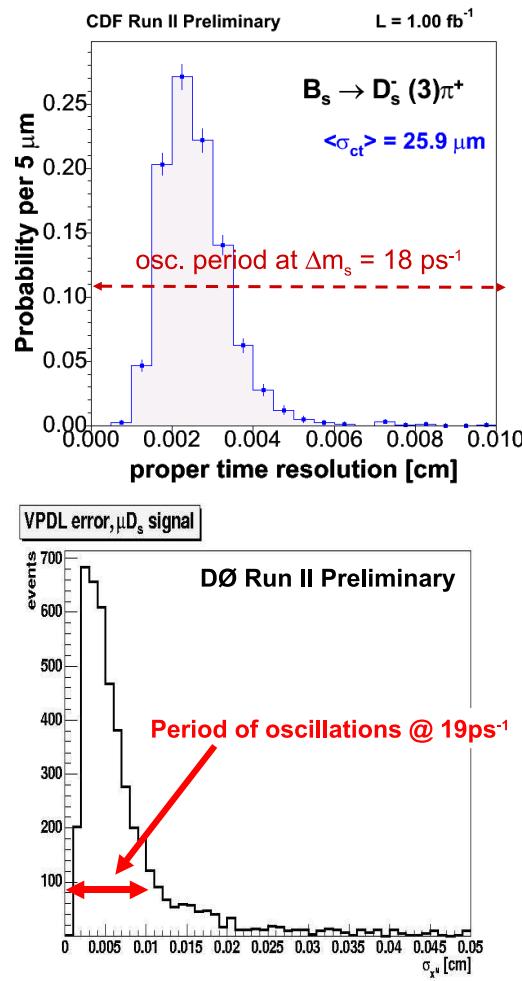
(Phys. Rev. Lett. 97, (2006) 062003)



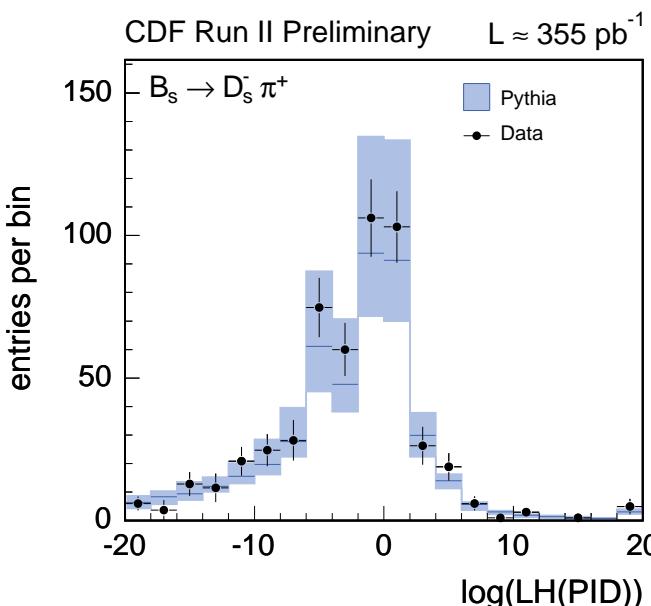
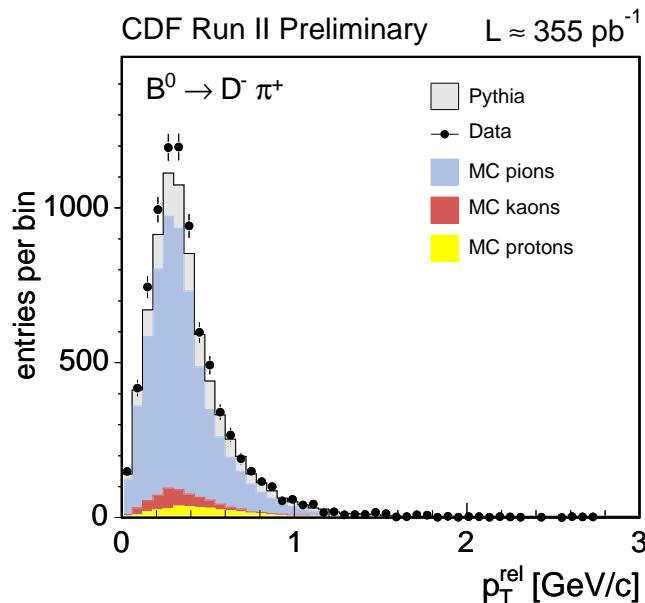
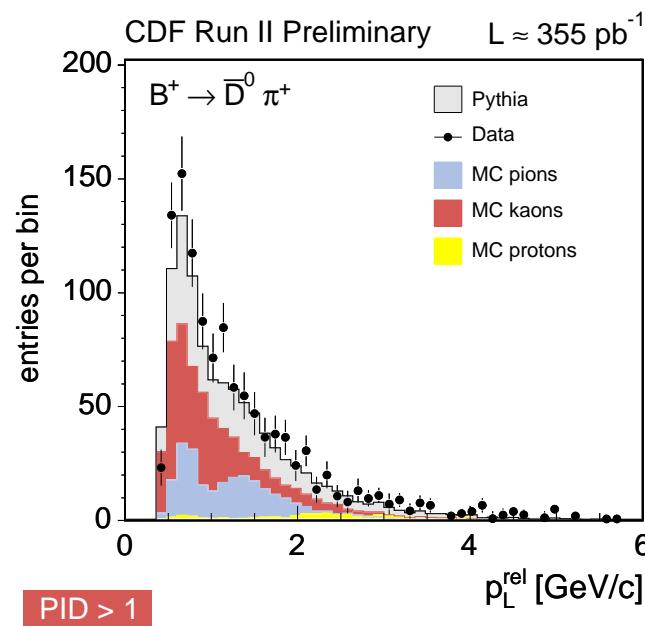
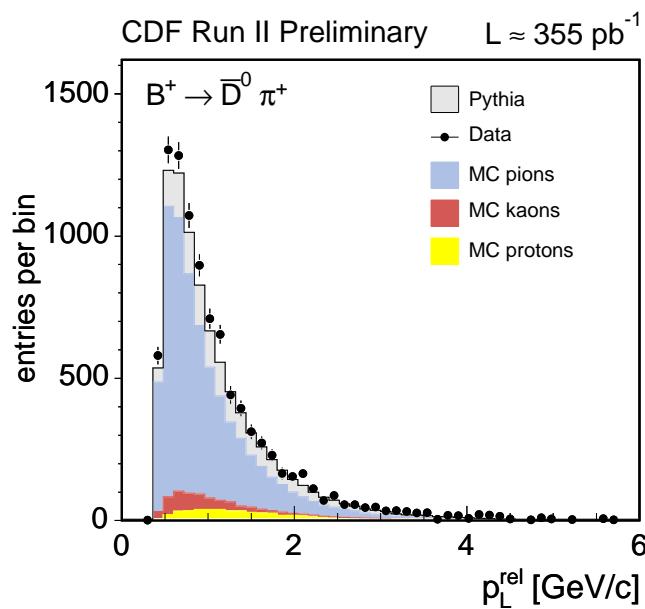
$$\Delta m_s = 17.31^{+0.33}_{-0.18}(\text{stat.}) \pm 0.07(\text{syst.}) \text{ ps}^{-1}$$

Proper Time Resolution

$$\sigma_{ct} = \sigma_{ct}^0 \oplus ct \frac{\sigma_p}{p}$$



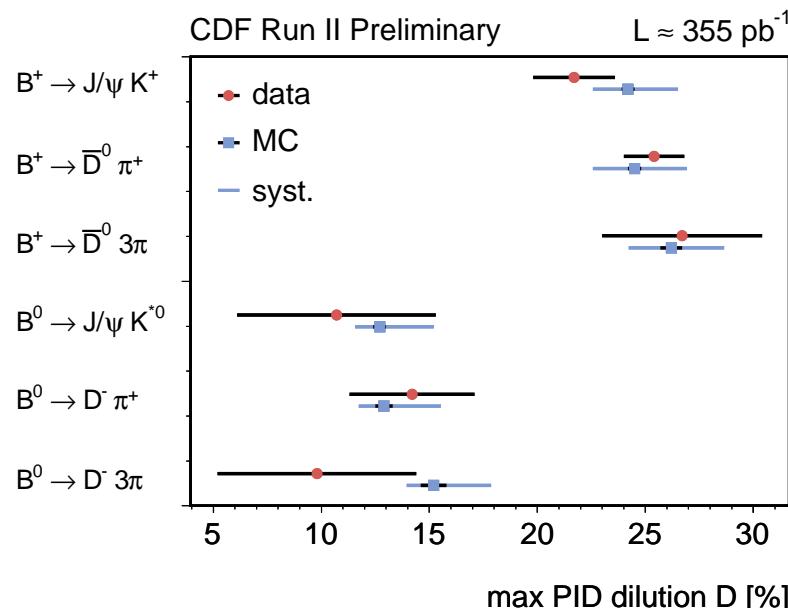
Same Side Tagger @ CDF (II)



Same Side Tagger @ CDF (III)

Systematic studies:

- Fragmentation
- Production mechanisms
- Particle ID resolution
- kaon/proton/pion rates
- B^{**} rates (for B^+ , B^0)
- Data/Monte Carlo agreement

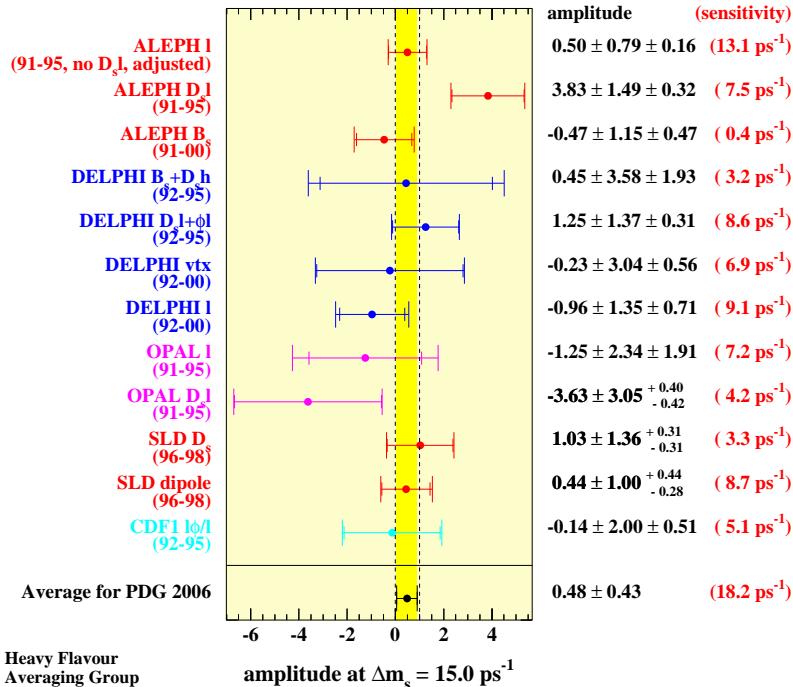


Very good data MC agreement for B^+ and B_d modes!

Status w/o Tevatron Run II Results

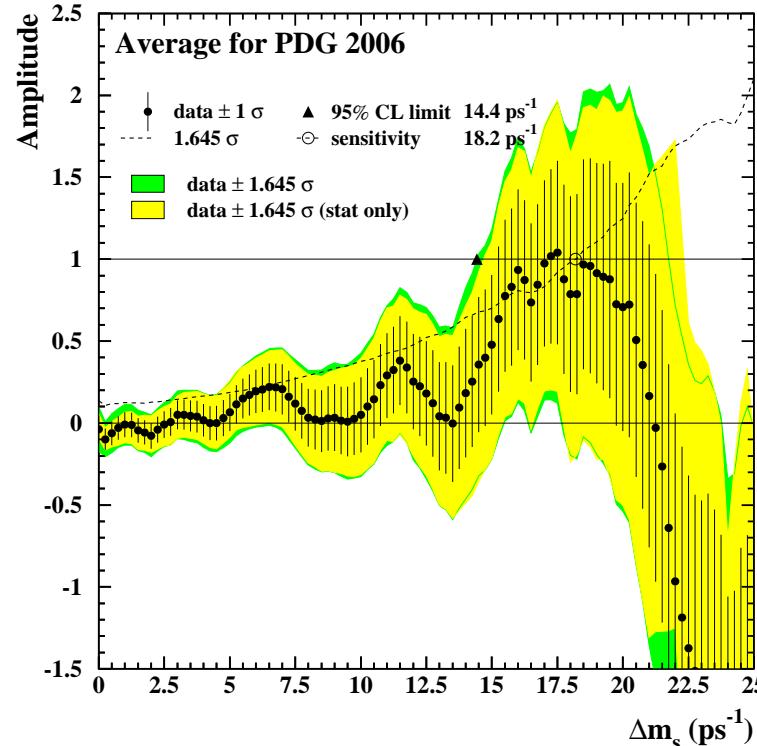
$$\Delta m_s > 14.4 \text{ ps}^{-1} \text{ 95% CL}$$

LEP + SLD + CDF Run I



$$A(\Delta m_s = 15 \text{ ps}^{-1}) = 0.48 \pm 0.43$$

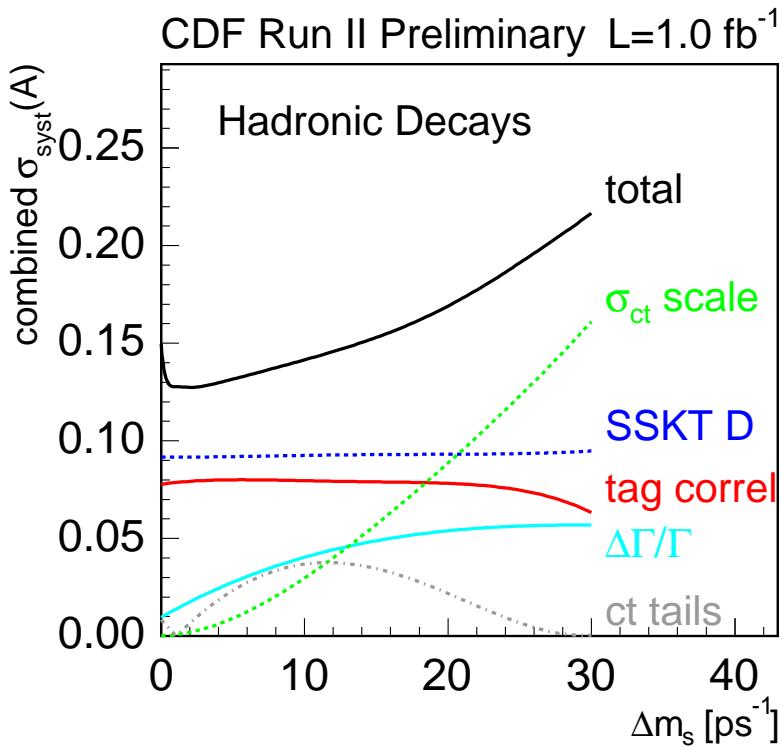
Sensitivity: 18.2 ps



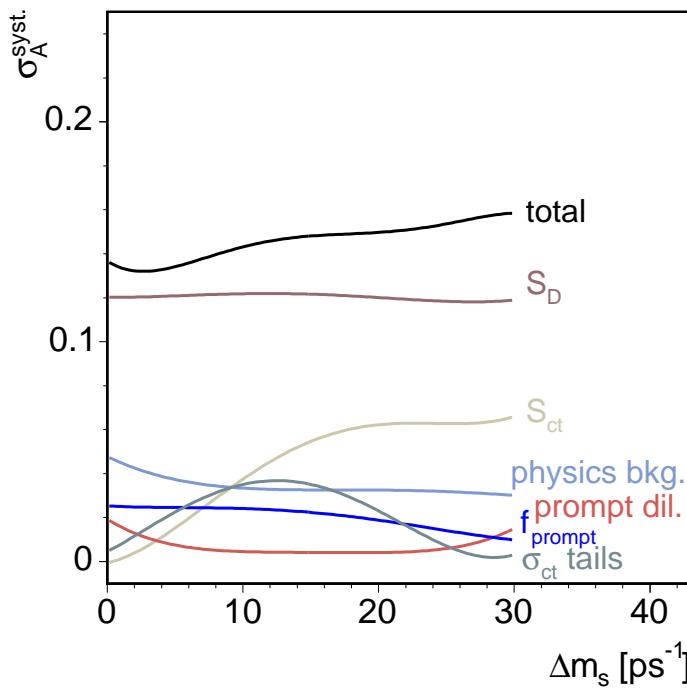
Amplitude method: H-G. Moser,
A. Roussaire, NIM **A384**, 491
(1997)

Systematic Uncertainties (CDF) (I)

Hadronic



Semileptonic



Systematic uncertainties $\sim 0.15\text{-}0.20$ at high Δm_s

Analysis limited by statistics

Systematic Uncertainties (CDF) (II)

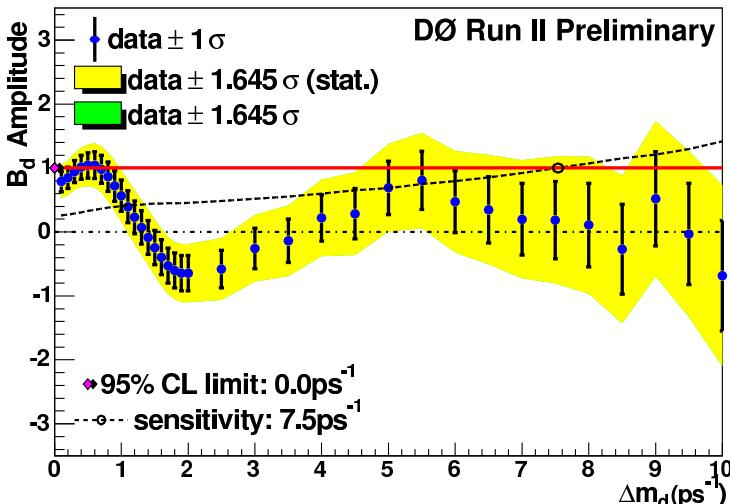
Source	Value (ps^{-1})
Silicon detector alignment	0.04
Track fit bias	0.05
Primary vertex bias	0.02
Hadronic k -factors	0.03
Amplitude scan systematic effects	< 0.01
Total	0.07

All relevant systematic uncertainties:

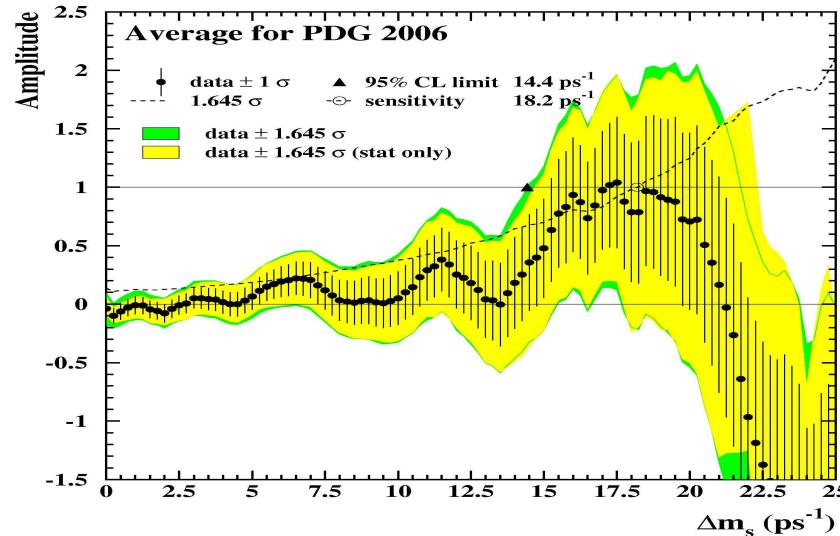
- related to ct scale
- common between hadronic and semileptonic samples

Amplitude Scan Notation

Test of amplitude scan on B_d data



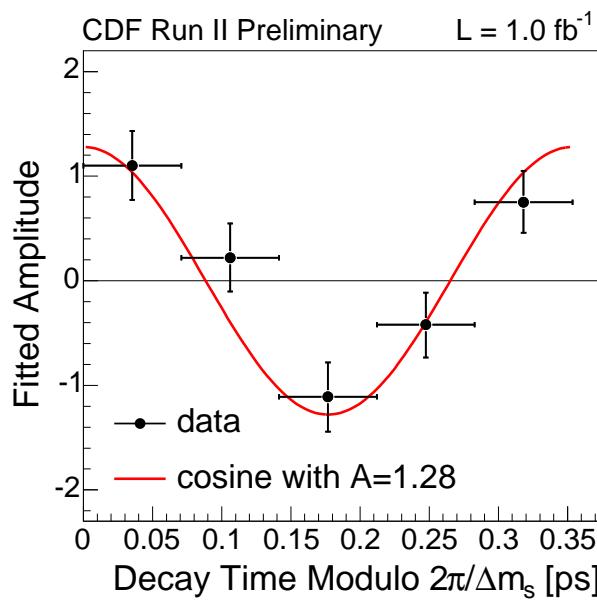
2006 world combined B_s scan



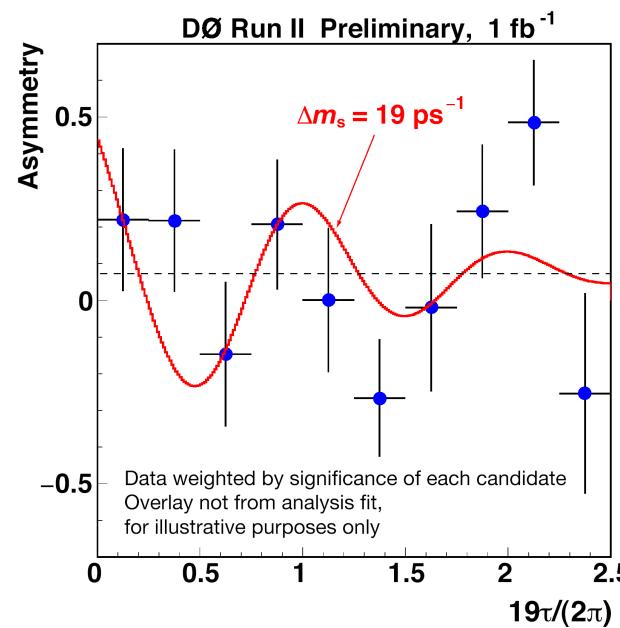
- Amplitude uncertainties from unbinned likelihood fit
- Yellow: 1.645σ around data points defines 95% CL region
- Δm values, where $\mathcal{A} + 1.645\sigma < 1$ are excluded at 95% CL
- Dashed line: 1.645σ as a function of Δm
- Sensitivity: Δm , where $1.645\sigma = 1$ first
- On average, we expect to observe mixing within sensitivity

Can we SEE the Asymmetrie?

CDF: Asymmetry modulo 17.77 ps^{-1} for hadronic modes



Unbinned LH fit, exploiting
event-by-event σ_{ct} & D

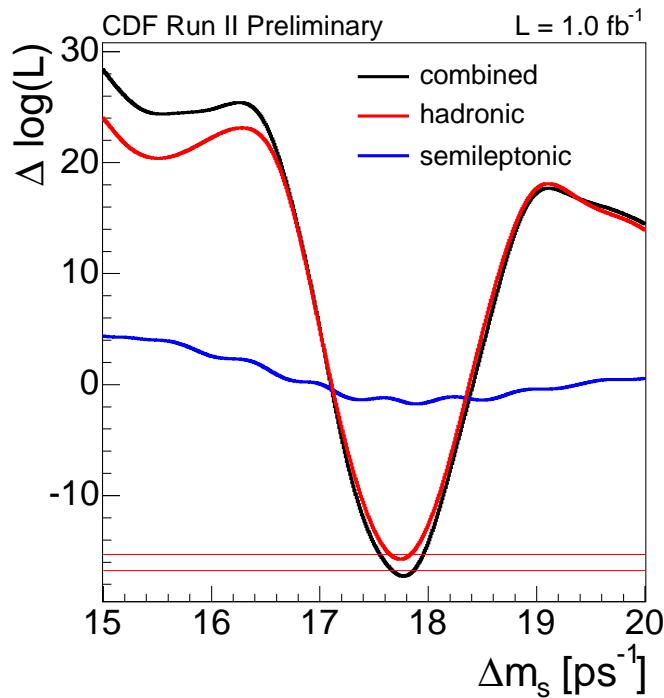


D0: data points weighted by significance

Δm_s Measurement (CDF)

Δm_s in $[17.00, 17.91] \text{ ps}^{-1}$ @ 90% C.L.

Δm_s in $[16.94, 17.97] \text{ ps}^{-1}$ @ 95% C.L.



$$\Delta m_s = 17.77 \pm 0.10(\text{stat.}) \pm 0.07(\text{syst.}) \text{ ps}^{-1}$$

Systematic dominated by uncertainties on ct scale
consistent with indirect SM fits: $\Delta m_s = 18.3^{+6.5}_{-1.5} \text{ ps}^{-1}$

$|V_{td}|/|V_{ts}|$ Measurement (CDF)

$$\frac{\Delta m_s}{\Delta m_d} = \frac{m_{B_s}}{m_{B_d}} \xi^2 \frac{|V_{ts}|^2}{|V_{td}|^2}$$

Input	Value	Source
$\frac{m(B^0)}{m(B_s)}$	0.98390	CDF 2006
ξ	$1.21^{+0.047}_{-0.035}$	Lattice 2005
Δm_d	0.507 ± 0.005	PDG 2006
Δm_s	$17.77 \pm +0.10 \pm +0.07$	this analysis

$$|V_{td}|/|V_{ts}| = 0.2061 \pm 0.0007(\text{exp.})^{+0.0081}_{-0.0060}(\text{theo.})$$

Measurement no longer determined by experimental uncertainties.

Belle measurement $b \rightarrow d\gamma$: $|V_{td}|/|V_{ts}| = 0.199^{+0.026}_{-0.025}(\text{exp.})^{+0.018}_{-0.015}(\text{theo.})$